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EMC TEST REPORT

Dates of Tests: April 24 – 26, 2019
Test Report S/N: LR500122304F
Test Site : LTA Co., Ltd.

Model No.

QNO-6032R

APPLICANT

Hanwha Vision Co., Ltd

Equipment Name : NETWORK CAMERA
Manufacturer : Hanwha Vision Co., Ltd
Model name : QNO-6032R
Additional Model name : QNO-6022R, QNO-6012R, QNO-6012R1, QNO-6022R1,
QNO-6032R1
Test Device Serial No.: : Identification
Directive : Electromagnetic Compatibility Directive 2014/30/EU
Regulations 2016/1091
Rule Part(s) : EN 55032:2015/A11:2020
EN 50130-4:2011
EN 61000-3-2:2014
EN 61000-3-3:2013
Data of reissue : April 12, 2023

This test report is issued under the authority of:

The test was supervised by:

Young Kyu Shin, Technical Manager

Jong chae Kim, Test Engineer

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NVLAP LAB CODE 200723-0

Revision	Date of issue	Test report No.	Description
0	03.05.2019	LR500121905E	Initial
1	10.08.2021	LR500122108D	Rule Update, Delete China Factory, Add Additional Models (QNO-6012R1, QNO-6022R1, QNO-6032R1),
2	12.04.2023	LR500122304F	Change company name and manufacturer name

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1. General information's

1-1 Test Performed

Company name : **LTA Co., Ltd**
 Address : 4, Songju-ro 236beon-gil, Yangji-myeon, Cheoin-gu, Yongin-si, Gyeonggi-do, 17159, Korea
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Quality control in the testing laboratory is implemented as per ISO/IEC 17025 which is the “General requirements for the competents of calibration and testing laboratory”.

1-2 Accredited agencies

LTA Co., Ltd. is approved to perform EMC testing by the following agencies:

Agency	Country	Accreditation No.	Validity	Reference
NVLAP	U.S.A	200723-0	2019-09-30	ECT accredited Lab.
RRA	KOREA	KR0049	-	EMC accredited Lab.
FCC	U.S.A	649054	2021-04-11	FCC CAB
VCCI	JAPAN	C-4948,	2020-09-10	VCCI registration
		T-2416,	2020-09-10	
		R-4483(10 m),	2020-10-15	
		G-10847	2022-06-13	
IC	CANADA	5799A-2	2019-06-15	IC filing
KOLAS	KOREA	NO.551	2021-08-20	KOLAS accredited Lab.

2. Information's about test item

2-1 Client/ Manufacturer

Company name : Hanwha Vision Co., Ltd
 Address : 6, Pangyo-ro 319 Beon-gil, Bundang-gu, Seongnam-si, Gyeonggi-do, 13488,
 : KOREA
 Telephone / Facsimile : +82-70-7147-8753(<http://hanhwa-security.com>)

Factory #1

Company name : HANWHA VISION VIETNAM COMPANY LIMITED
 Address : Lot O-2, Que Vo Industrial Zone extended area ,Nam Son commune, Bac Ninh
 city,Bac Ninh province, Vietnam

Factory #2

Company name : D-TECH CO.,LTD.
 Address : 173-25, Saneop-ro, Gwonseon-gu, Suwon-si, Gyeonggi-do, Korea (Suwon Industrial
 Complex)

2-2 Equipment Under Test (EUT)

Class : A
 Equipment Name : NETWORK CAMERA
 Model name : QNO-6032R
 Additional Model name : QNO-6022R, QNO-6012R, QNO-6012R1, QNO-6022R1, QNO-6032R1
 Additional Models are different only lens specification.
 Serial number : Identification
 Date of receipt : April 09, 2019
 EUT condition : Pre-production, not damaged
 Interface Ports : DC IN, LAN, Alarm IN, Alarm OUT, Alarm Ground, MIC
 Video OUT Port is a management Port.
 Power rating : DC 12 V (Adapter), DC 48 V (PoE)

2-3 Modification

-NONE

2-4 Test conditions

Temp. / Humid. / Pressure : +(21 - 24) °C / (38 - 39) % R.H. / (100) kPa
 Tested Model : QNO-6032R
 Test mode : Rec mode (Adapter), Rec mode (PoE)
 Tested Voltage : AC 230 V, 50 Hz (Adapter, PoE)

2-5 EUT

Equipment	Model No.	Serial No.	Manufacturer
NETWORK CAMERA	QNO-6032R	N/A	Hanwha Vision Co., Ltd

2-6 Accessory / Rec mode (Adapter)

Equipment	Model No.	Serial No.	Manufacturer
Notebook	P56	N/A	HANSUNG
Notebook Adapter	A10-090P3A	N/A	Chicony
Alarm	N/A	N/A	N/A
Sensor	SPL-0030	N/A	SECOM
SD Card	KTJD8K9	N/A	N/A
Adapter	AH1212-K	N/A	JENTEC TECHNOLOGY CO., LTD
Mobile Phone	Gal	N/A	SAMSUNG

/ Rec mode (PoE)

Equipment	Model No.	Serial No.	Manufacturer
Notebook	P56	N/A	HANSUNG
Notebook Adapter	A10-090P3A	N/A	Chicony
Alarm	N/A	N/A	N/A
Sensor	SPL-0030	N/A	SECOM
SD Card	KTJD8K9	N/A	N/A
Mobile Phone	Gal	N/A	SAMSUNG
PoE Injector	GT96300-3656-T3-APOE	N/A	GlabTek, Inc

2-7 Cable List / Rec mode (Adapter)

From		To		Length (m)	Shielding	
Type	I/O Port	Type	I/O Port		Cable	backshell
EUT	DC IN	Adapter	DC OUT	1.2	NO	Plastic
	LAN	Notebook	LAN	3.0	NO	Plastic
	Alarm IN	Alarm	Alarm OUT	1.0	NO	Plastic
	Alarm OUT	Sensor	Sensor OUT	1.0	NO	Plastic
	Alarm Ground	Alarm	Alarm Ground	1.0	NO	Plastic
	Alarm Ground	Sensor	Sensor Ground	1.0	NO	Plastic
	SD Card	SD Card	-	-	-	-
	MIC	Mobile Phone	AUX	1.2	NO	Plastic
Notebook	DC IN	Notebook Adapter	DC OUT	1.5	NO	Plastic
Notebook Adapter	AC IN	AC Power Source	3 Pin AC Line	1.5	NO	Plastic

/ Rec mode (PoE)

From		To		Length (m)	Shielding	
Type	I/O Port	Type	I/O Port		Cable	backshell
EUT	LAN	PoE Injector	DATA/Power	3.0	NO	Plastic
	Alarm IN	Alarm	Alarm OUT	1.0	NO	Plastic
	Alarm OUT	Sensor	Sensor OUT	1.0	NO	Plastic
	Alarm Ground	Alarm	Alarm Ground	1.0	NO	Plastic
	Alarm Ground	Sensor	Sensor Ground	1.0	NO	Plastic
	SD Card	SD Card	-	-	-	-
	MIC	Mobile Phone	AUX	1.2	NO	Plastic
PoE Inejctor	DATA	PoE Injector	LAN	3.0	NO	Plastic
	AC IN	AC Power Source	3 Pin AC Line	1.5	NO	Plastic
Notebook	DC IN	Notebook Adapter	DC OUT	1.5	NO	Plastic
Notebook Adapter	AC IN	AC Power Source	3 Pin AC Line	1.5	NO	Plastic

3. Test Report

3.1 Summary of tests

Parameter	Applied Standard	Status
I. Emission		
Radiated Emission	EN 55032:2015/A11:2020	C
Conducted Emission	EN 55032:2015/A11:2020	C
Harmonic Current Emission	EN 61000-3-2:2014	NA ^{Note 3}
Voltage Fluctuations and Flicker	EN 61000-3-3:2013	C
II. Immunity		
Electrostatic Discharge	EN 61000-4-2:2009	C
RF Electromagnetic field	EN 61000-4-3:2006/A1:2008/A2:2010	C
Fast Transients Common mode	EN 61000-4-4:2012	C
Surges, line to line and line to ground	EN 61000-4-5:2014/A1:2017	C
RF common mode	EN 61000-4-6:2014/AC:2015	C
Voltage dips and Interruptions	EN 61000-4-11:2004/A1:2017	C
Main supply voltage variations	EN 50130-4:2011/A1:2014	C

Note 1: C=Complies NC=Not Complies NT=Not Tested NA=Not Applicable

Note 2: The data in this test report are traceable to the national or international standards.

Note 3: We did not test EN61000-3-2 (Harmonic current emissions) for the QNO-6032R because equipment whose rated power is less or equal 75W don't need to be tested.

3.2 EMISSION

3.2.1 Conducted emissions

Definition:

The test assesses the ability of the EUT to limit its internal noise from being present on the AC mains Power In/Output ports.

We were performed the test according to LTA procedure LTA-QI-04.

Measurement Frequency range	: 150 kHz – 30 MHz
Test method	: EN 55032:2012/AC2013
Measurement RBW	: 9 kHz
Test mode	: Rec mode (Adapter), Rec mode (PoE)
Result	: Complies

Measurement Data:

- Refer to the Next page (Maximum emission configuration)

A sample calculation:

COR. F (correction factor)= LISN Insertion loss + Cable loss + Pulse Limiter Factors

Emission Level= meter reading + COR.F

Limits for conducted disturbance at the mains ports of class A ITE

Frequency Range	Quasi-peak	Average
(0.15 – 0.5) MHz	79 dBuV	66 dBuV
(0.5 – 30) MHz	73 dBuV	60 dBuV

Note: The limits will decrease with the frequency logarithmically within 0.15MHz to 0.5MHz

Limits for conducted disturbance at the mains ports of class B ITE

Frequency Range	Quasi-peak	Average
(0.15 – 0.5) MHz	(66 – 56) dBuV	(56 - 46) dBuV
(0.5 – 5) MHz	56 dBuV	46 dBuV
(5 – 30) MHz	60 dBuV	50 dBuV

Note: The limits will decrease with the frequency logarithmically within 0.15 MHz to 0.5 MHz

Limits of conducted common mode (asymmetric mode) disturbance at telecommunication ports in the frequency range 0.15 MHz to 30 MHz for class A equipment

Frequency Range	Voltage limits		Current limits	
	Quasi-peak	Average	Quasi-peak	Average
(0.15 – 0.5) MHz	(97 – 87) dBuV	(84 – 74) dBuV	(53 – 43) dBuV	(40 – 30) dBuV
(0.5 – 30) MHz	87 dBuV	74 dBuV	43 dBuV	30 dBuV

Note 1: The limits decrease linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.

Note 2: The current and voltage disturbance limits are derived for use with an impedance stabilization network (ISN) which presents a common mode (asymmetric mode) impedance of 150Ω to the telecommunication port under test (conversion factor is $20 \log_{10} 150/I = 44$ dB)

Limits of conducted common mode (asymmetric mode) disturbance at telecommunication ports in the frequency range 0.15 MHz to 30 MHz for class B equipment

Frequency Range	Voltage limits		Current limits	
	Quasi-peak	Average	Quasi-peak	Average
(0.15 – 0.5) MHz	(84 – 74) dBuV	(74 – 64) dBuV	(40 – 30) dBuV	(30 – 20) dBuV
(0.5 – 30) MHz	74 dBuV	64 dBuV	30 dBuV	20 dBuV

Note 1: The limits decrease linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.

Note 2: The current and voltage disturbance limits are derived for use with an impedance stabilization network (ISN) which presents a common mode (asymmetric mode) impedance of 150Ω to the telecommunication port under test (conversion factor is $20 \log_{10} 150/I = 44$ dB)

Conducted emissions (LINE) / Rec mode (Adapter)



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EUT /Model No. : QNO-6032R

Phase : Line

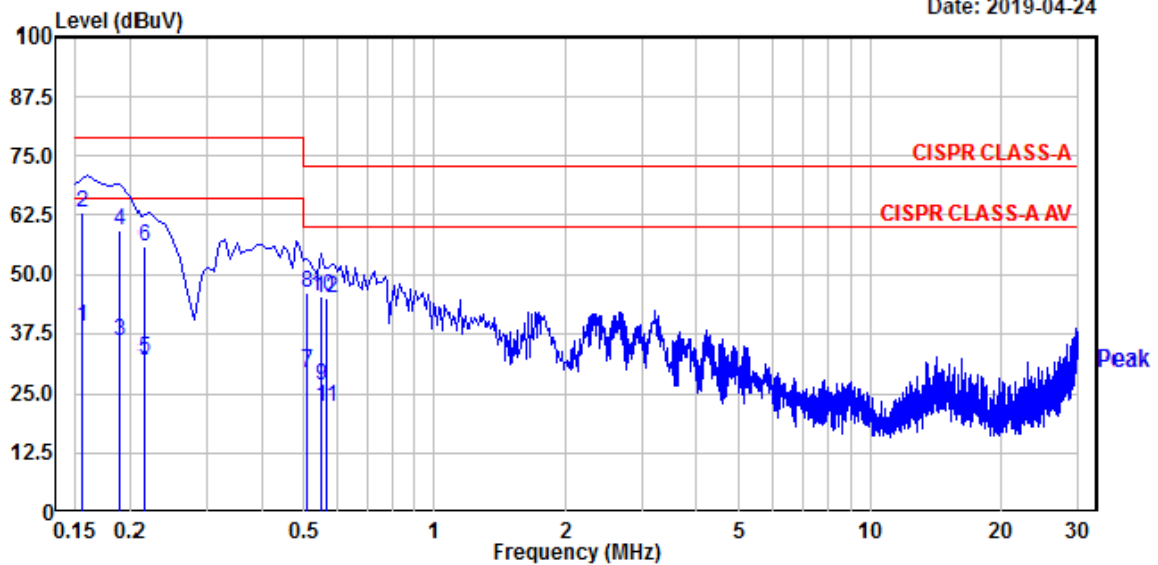
Test Mode : Rec mode (Adapter)

Test Power : 230 / 50

Temp./ Humi. : 21°C / 39% R.H.

Test Engineer : LEE G W

Date: 2019-04-24



Trace: 1

Freq MHz	RD QP dBuV	RD AV dBuV	C.F dB	Result QP dBuV	Result AV dBuV	Limit QP dBuV	Limit AV dBuV	Margin QP dB	Margin AV dB
0.156	43.76	19.61	19.43	63.19	39.04	79.00	66.00	15.81	26.96
0.190	39.78	16.31	19.44	59.22	35.75	79.00	66.00	19.78	30.25
0.215	36.39	12.52	19.44	55.83	31.96	79.00	66.00	23.17	34.04
0.511	26.66	9.80	19.47	46.13	29.27	73.00	60.00	26.87	30.73
0.551	25.73	7.22	19.47	45.20	26.69	73.00	60.00	27.80	33.31
0.563	25.34	2.89	19.47	44.81	22.36	73.00	60.00	28.19	37.64

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

Conducted emissions (NEUTRAL) / Rec mode (Adapter)



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EUT /Model No. : QNO-6032R

Phase : Neutral

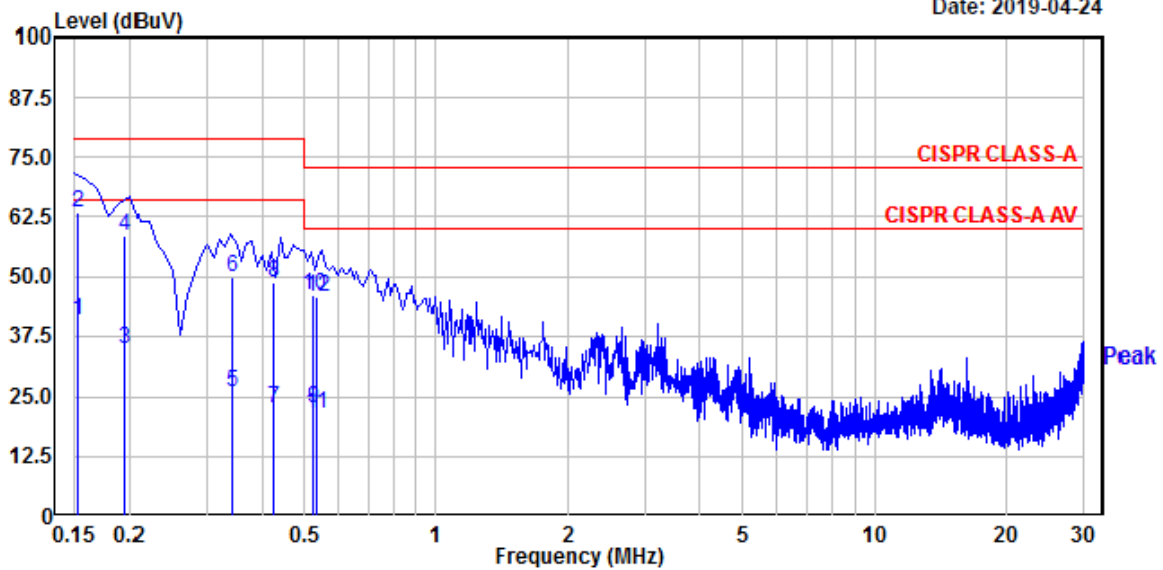
Test Mode : Rec mode (Adapter)

Test Power : 230 / 50

Temp./ Humi. : 21°C / 39% R.H.

Test Engineer : LEE G W

Date: 2019-04-24



Trace: 1

Freq	RD	RD	C.F	Result	Result	Limit	Limit	Margin	Margin
MHz	QP	AV		QP	AV	QP	AV	QP	AV
	dBuV	dBuV	dB	dBuV	dBuV	dBuV	dBuV	dB	dB
0.153	43.87	21.32	19.44	63.31	40.76	79.00	66.00	15.69	25.24
0.195	39.20	15.40	19.44	58.64	34.84	79.00	66.00	20.36	31.16
0.341	30.20	6.61	19.46	49.66	26.07	79.00	66.00	29.34	39.93
0.427	29.10	3.32	19.46	48.56	22.78	79.00	66.00	30.44	43.22
0.523	26.52	3.05	19.47	45.99	22.52	73.00	60.00	27.01	37.48
0.534	26.19	2.03	19.47	45.66	21.50	73.00	60.00	27.34	38.50

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

Conducted emissions (TEL_100 M) / Rec mode (Adapter)



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EUT /Model No. : QNO-6032R

Phase : TEL_100M

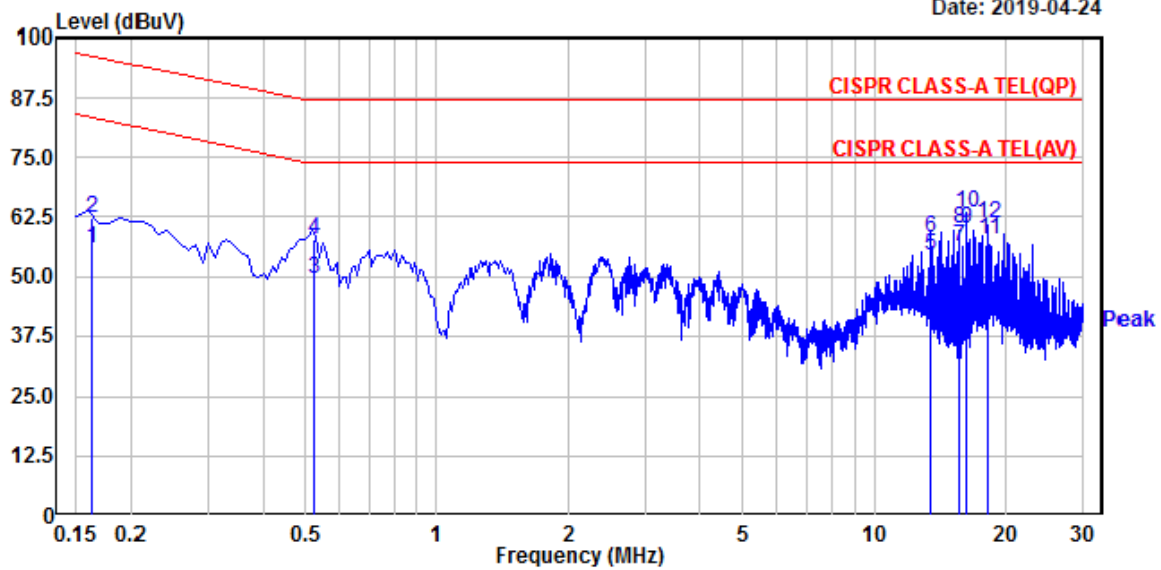
Test Mode : Rec mode (Adapter)

Test Power : 230 / 50

Temp./ Humi. : 21°C / 39% R.H.

Test Engineer : LEE G W

Date: 2019-04-24



Trace: 1

Freq MHz	RD QP dBuV	RD AV dBuV	C.F dB	Result QP dBuV	Result AV dBuV	Limit QP dBuV	Limit AV dBuV	Margin QP dB	Margin AV dB
0.164	42.67	35.92	19.76	62.43	55.68	96.28	83.28	33.85	27.60
0.522	38.22	29.83	19.50	57.72	49.33	87.00	74.00	29.28	24.67
13.419	38.28	34.60	19.68	57.96	54.28	87.00	74.00	29.04	19.72
15.617	40.11	36.65	19.73	59.84	56.38	87.00	74.00	27.16	17.62
16.229	43.77	40.31	19.76	63.53	60.07	87.00	74.00	23.47	13.93
18.243	41.42	37.90	19.81	61.23	57.71	87.00	74.00	25.77	16.29

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

Conducted emissions (TEL_100 M) / Rec mode (PoE)



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EUT /Model No. : QNO-6032R

Phase : TEL_100M

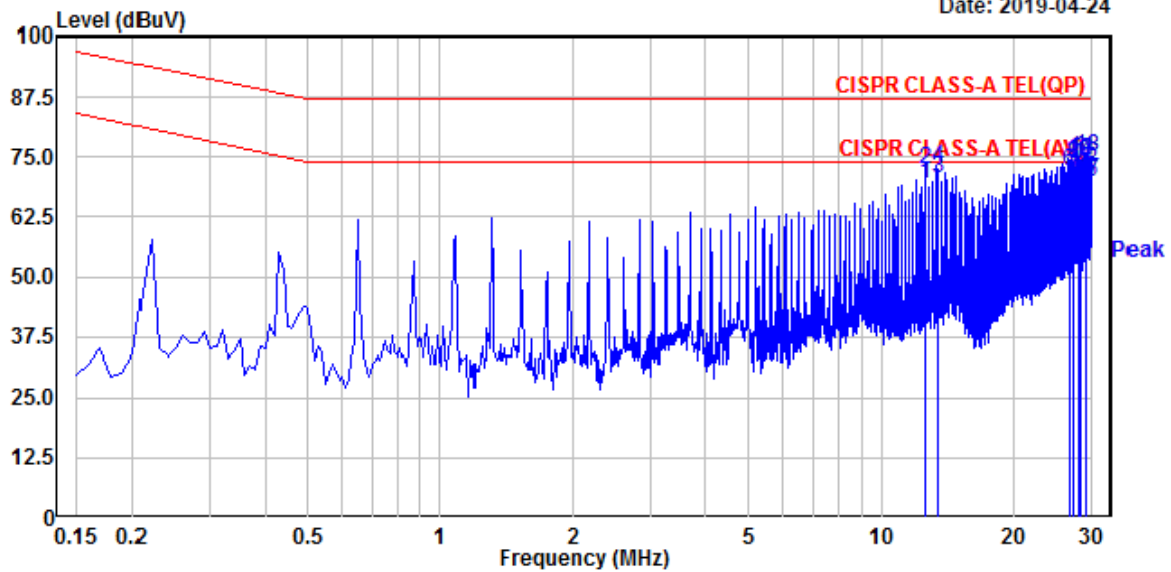
Test Mode : Rec mode (PoE)

Test Power : 230 / 50

Temp./ Humi. : 21°C / 39% R.H.

Test Engineer : LEE G W

Date: 2019-04-24



Trace: 1

Freq	RD	RD	C.F	Result	Result	Limit	Limit	Margin	Margin
MHz	QP	AV	dB	QP	AV	QP	AV	QP	AV
	dBuV	dBuV		dBuV	dBuV	dBuV	dBuV	dB	dB
12.589	52.63	49.84	19.66	72.29	69.50	87.00	74.00	14.71	4.50
13.456	53.22	50.82	19.68	72.90	70.50	87.00	74.00	14.10	3.50
26.700	51.83	47.13	20.10	71.93	67.23	87.00	74.00	15.07	6.77
27.347	53.46	50.66	20.12	73.58	70.78	87.00	74.00	13.42	3.22
28.001	53.68	49.35	20.15	73.83	69.50	87.00	74.00	13.17	4.50
28.217	54.02	51.41	20.15	74.17	71.56	87.00	74.00	12.83	2.44
28.433	54.66	49.92	20.16	74.82	70.08	87.00	74.00	12.18	3.92
29.088	53.45	49.61	20.19	73.64	69.80	87.00	74.00	13.36	4.20
29.302	54.99	50.17	20.20	75.19	70.37	87.00	74.00	11.81	3.63

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss + Pulse Limiter

3.2.2 Radiated Emission

Definition:

The test assesses the ability of ancillary equipment to limit their internal noise from being radiated from the enclosure.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	: EN 55032:2012/AC2013
Measuring Distance	: 10 m for below 1 GHz / 3 m for above 1 GHz
Measurement Frequency range	: 30 MHz – 6 000 MHz
Measurement RBW	: 120 kHz @ 10 m / 1 MHz @ 3 m
Test mode	: Rec mode (Adapter), Rec mode (PoE)
Result	: Complies

Measurement Data:

- Refer to the Next page (Maximum emission configuration)

- The highest internal source of an EUT is higher than 108 MHz, the measurement shall be made up to 6 GHz.

(The highest internal source of an EUT : higher than 108 MHz)

A sample calculation:

COR. F (correction factor)= Antenna factor + Cable loss- Amp.gain- Distance correction

Emission Level= meter reading + COR.F

Limit of 10 m for below 1 GHz

CLASS A

Frequency Range	Quasi-peak
(30 – 230) MHz	40 dBuV/m
(230 – 1 000) MHz	47 dBuV/m

CLASS B

Frequency Range	Quasi-peak
(30 – 230) MHz	30 dBuV/m
(230 – 1 000) MHz	37 dBuV/m

Limit of 3m for above 1 GHz

CLASS A

Frequency Range	Average Limit @ 3m (dB μ V/m)	Peak limit @ 3m (dB μ V/m)
(1 000 – 3 000) MHz	56	76
(3 000 – 6 000) MHz	60	80
NOTE:	The lower limit applies at the transition frequency.	

CLASS B

Frequency Range	Average Limit @ 3m (dB μ V/m)	Peak limit @ 3m (dB μ V/m)
(1 000 – 3 000) MHz	50	70
(3 000 – 6 000) MHz	54	74
NOTE:	The lower limit applies at the transition frequency.	

Radiated Emission (Below 1 GHz) / V _ Rec mode (Adapter)



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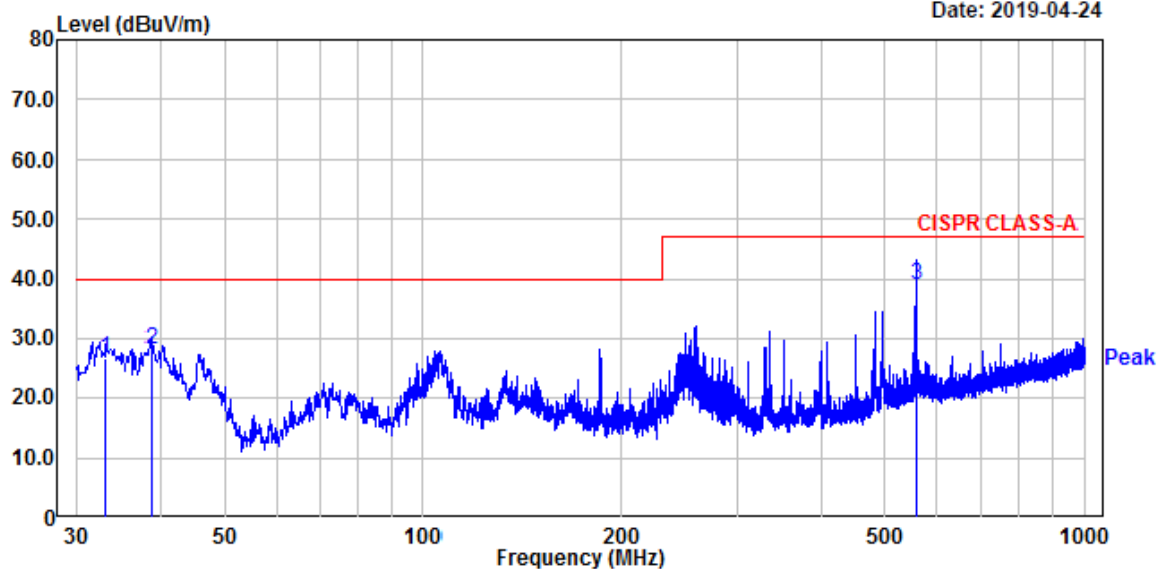
EUT/Model No.: QN0-6032R

Temp/Humi: 23 / 36

Test Mode : Rec mode (Adapter)

Tested by: LEE G W

Date: 2019-04-24



Freq	Reading	C.F	Result	Limit	Margin	Height	Angle	Polarity
MHz	dBuV	dB	QP dBuV/m	dBuV/m	dB	cm	deg	
33.11	41.61	-14.95	26.66	40.00	13.34	113	82	vertical
38.73	42.38	-14.18	28.20	40.00	11.80	100	276	vertical
556.83	45.41	-6.32	39.09	47.00	7.91	100	194	vertical

Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain

Radiated Emission (Below 1 GHz) / H _ Rec mode (Adapter)



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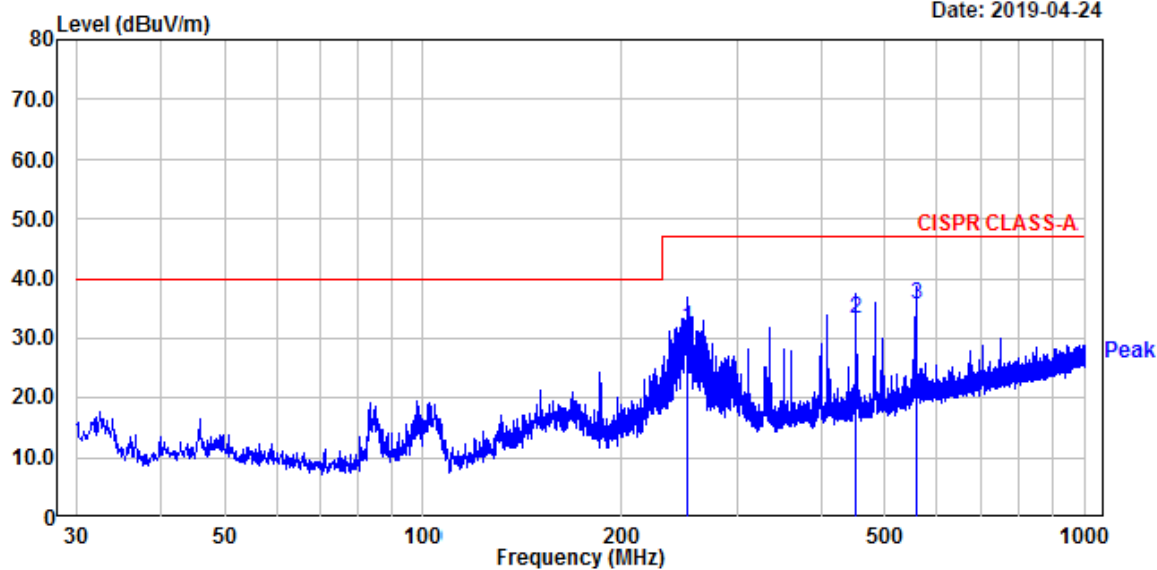
EUT/Model No.: QN0-6032R

Temp/Humi: 23 / 36

Test Mode : Rec mode (Adapter)

Tested by: LEE G W

Date: 2019-04-24



Freq	Reading	C.F	Result	Limit	Margin	Height	Angle	Polarity
MHz	dBuV	dB	QP dBuV/m	dBuV/m	dB	cm	deg	
251.60	44.57	-12.91	31.66	47.00	15.34	395	56	horizontal
450.01	41.23	-7.89	33.34	47.00	13.66	263	290	horizontal
556.83	42.07	-6.32	35.75	47.00	11.25	269	158	horizontal

Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain

Radiated Emission (Below 1 GHz) / V _ Rec mode (PoE)



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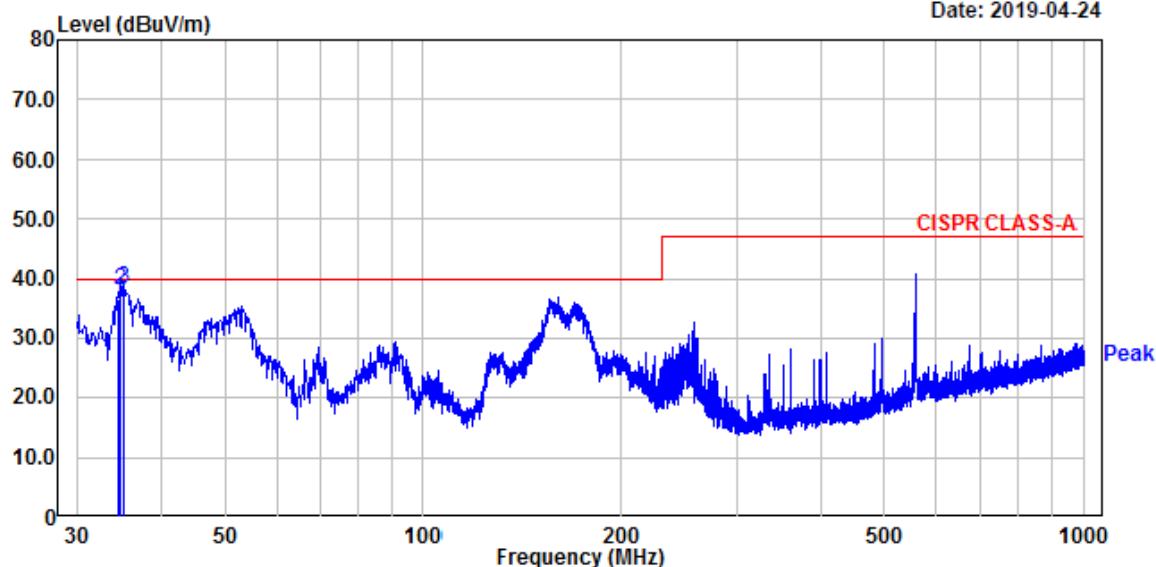
EUT/Model No.: QNO-6032R

Temp/Humi: 23 / 36

Test Mode : Rec mode (PoE)

Tested by: LEE G W

Date: 2019-04-24



Freq	Reading	C.F	Result	Limit	Margin	Height	Angle	Polarity
MHz	dBuV	dB	QP dBuV/m	dBuV/m	dB	cm	deg	
34.61	51.28	-14.77	36.51	40.00	3.49	100	220	vertical
34.85	52.82	-14.73	38.09	40.00	1.91	106	280	vertical
35.34	53.02	-14.69	38.33	40.00	1.67	100	160	vertical

Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain

Radiated Emission (Below 1 GHz) / H _ Rec mode (PoE)



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Yongin-si, Gyeonggi-do, Korea
Tel : +82-31-3236008,9
Fax : +82-31-3236010
www.ltalab.com

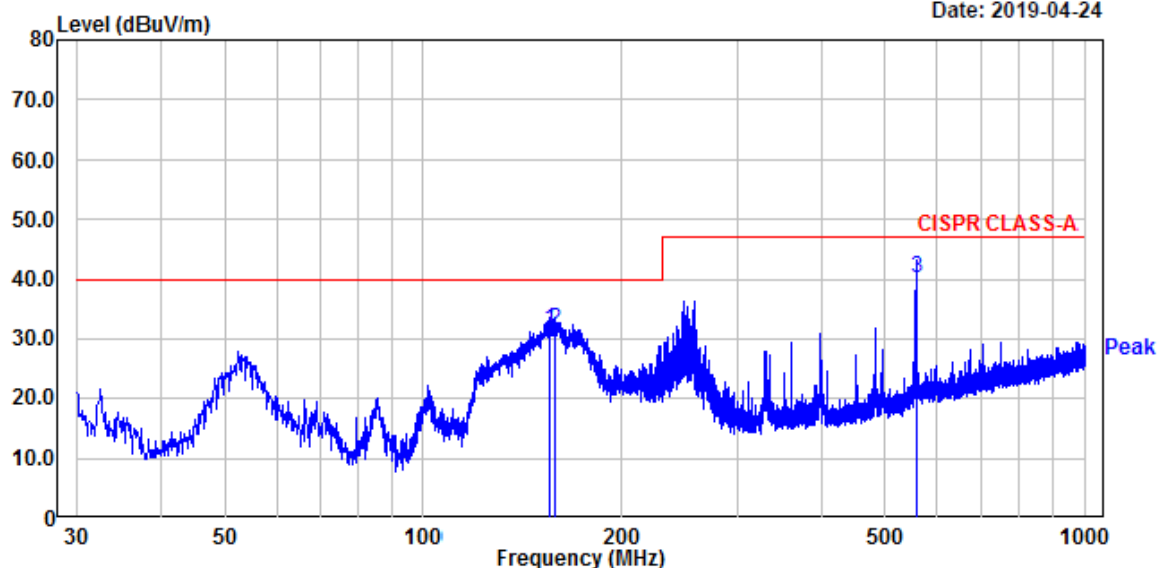
EUT/Model No.: QNO-6032R

Temp/Humi: 23 / 36

Test Mode : Rec mode (PoE)

Tested by: LEE G W

Date: 2019-04-24



Freq	Reading	C.F	Result	Limit	Margin	Height	Angle	Polarity
MHz	dBuV	dB	QP dBuV/m	dBuV/m	dB	cm	deg	
154.89	43.83	-12.41	31.42	40.00	8.58	247	209	horizontal
158.04	43.83	-12.38	31.45	40.00	8.55	291	184	horizontal
556.83	46.55	-6.32	40.23	47.00	6.77	309	59	horizontal

Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain

Radiated Emission / Rec mode (Adapter)

(Above 1 GHz) / H

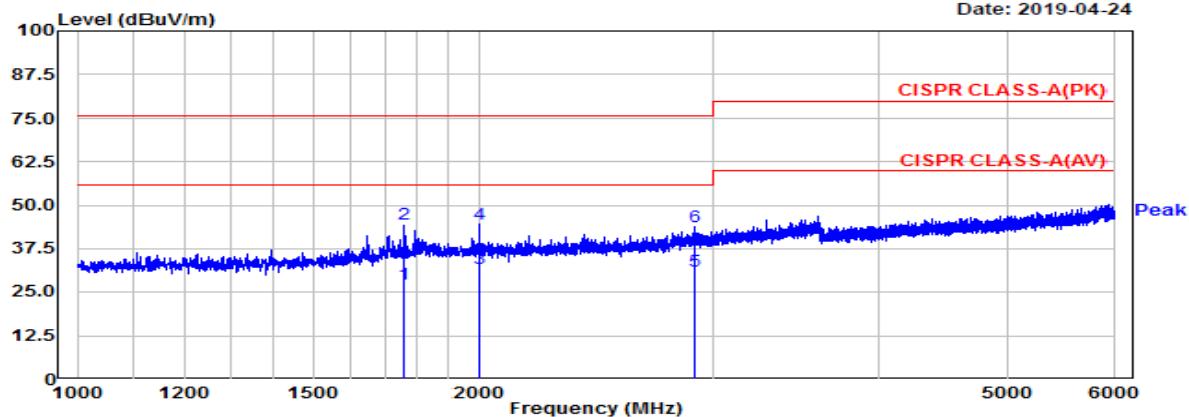
EUT/Model No.: QNO-6032R

Temp/Humi: 23 / 36

Test Mode : Rec mode (Adapter)

Tested by: LEE G W

Date: 2019-04-24



(Above 1 GHz) / V

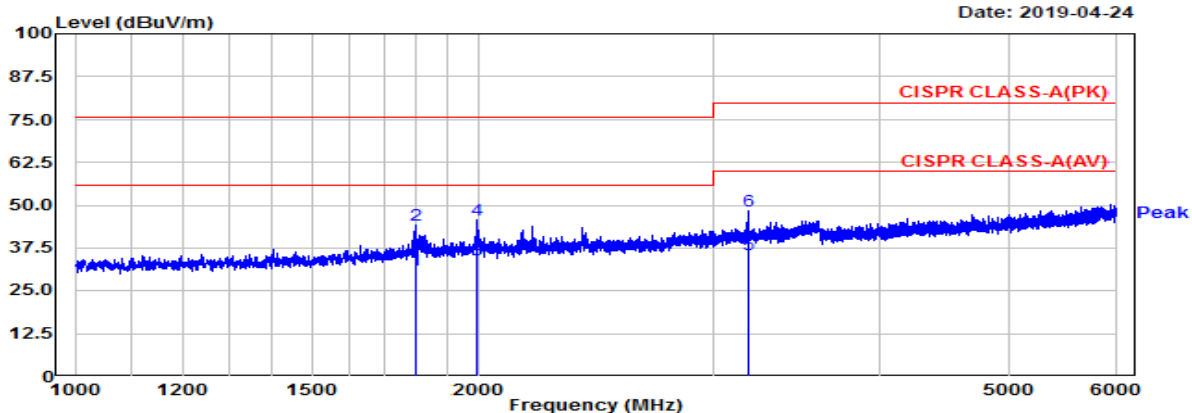
EUT/Model No.: QNO-6032R

Temp/Humi: 23 / 36

Test Mode : Rec mode (Adapter)

Tested by: LEE G W

Date: 2019-04-24



Manufacture : Hanwha Techwin (Tianjin) Co., Ltd.

Test Date

Temp.:
[°C]Humidity:
[%]Distance
(m)

Model : QNO-6032R

2019-04-24

23

36

3.8

TEST mode : Rec mode (Adapter)

Freq.(MHz)	Reading(PK)	Reading(AV)	C.F	Result(PK)	Result(AV)	Limit(PK)	Limit(AV)	Margin(PK)	Margin(AV)	Height	Angle	Polarity
MHz	dBuV	dBuV	dB	dBuV/m	dBuV/m	dBuV/m	dBuV/m	dB	dB	cm	deg	Hor/Ver
1760.00	49.4	32.1	-2.87	46.48	29.18	76.0	56.0	29.52	26.82	100	261	H
1999.30	46.4	33.4	0.30	46.69	33.69	76.0	56.0	29.31	22.31	100	345	H
2911.80	41.9	28.9	3.96	45.89	32.89	76.0	56.0	30.11	23.11	100	231	H
1800.00	47.4	34.4	-1.32	46.06	33.06	76.0	56.0	29.94	22.94	100	161	V
1993.13	47.5	35.5	0.36	47.86	35.86	76.0	56.0	28.14	20.14	100	107	V
3190.00	44.7	31.7	5.78	50.50	37.50	80.0	60.0	29.50	22.50	100	89	V

Radiated Emission / Rec mode (PoE)

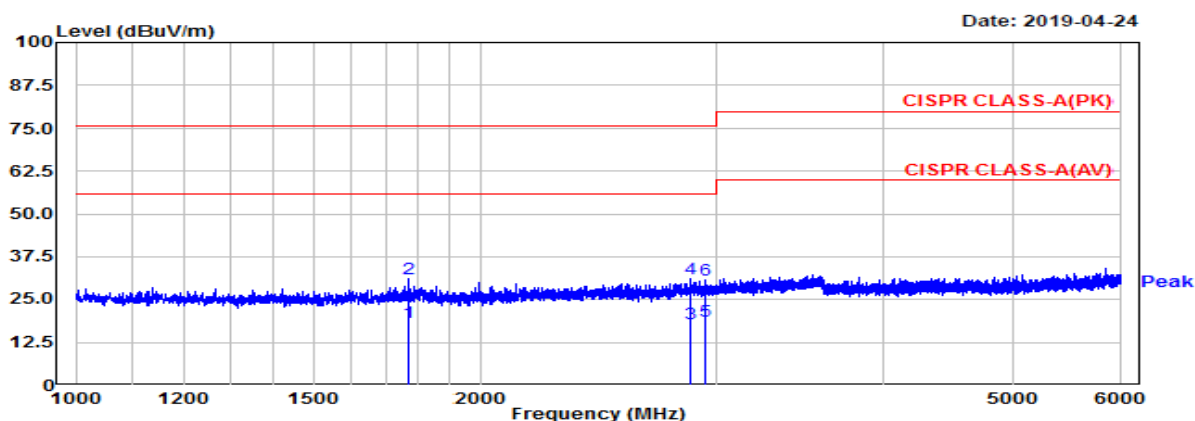
(Above 1 GHz) / H

EUT/Model No.: QNO-6032R

Temp/Humi: 23 / 36

Test Mode : Rec mode (PoE)

Tested by: LEE G W



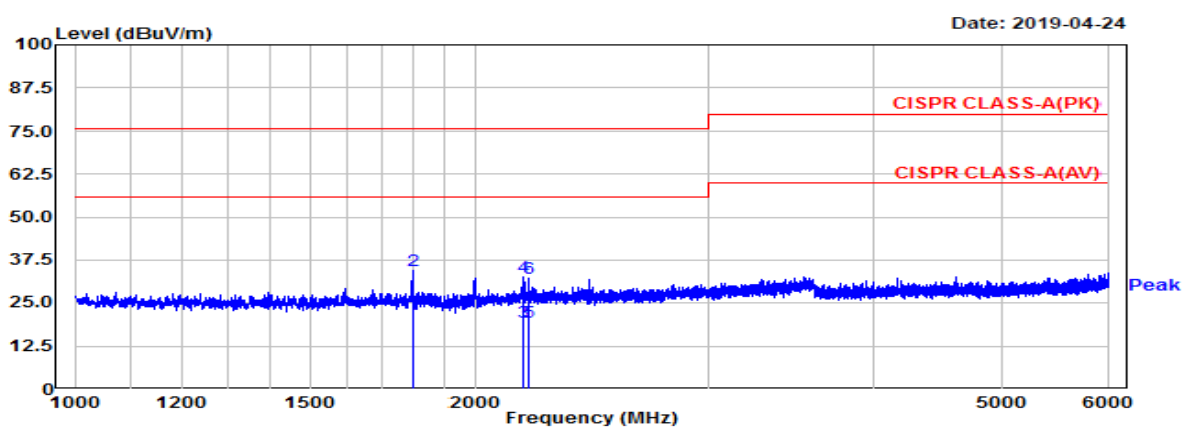
(Above 1 GHz) / V

EUT/Model No.: QNO-6032R

Temp/Humi: 23 / 36

Test Mode : Rec mode (PoE)

Tested by: LEE G W



Manufacture : Hanwha Techwin (Tianjin) Co., Ltd.

Test Date

Temp.: [°C]

Humidity: [%]

Distance (m)

Model : QNO-6032R

2019-04-24

23

36

3.8

TEST mode : Rec mode (PoE)

Freq.(MHz)	Reading(PK)	Reading(AV)	C.F	Result(PK)	Result(AV)	Limit(PK)	Limit(AV)	Margin(PK)	Margin(AV)	Height	Angle	Polarity
MHz	dBuV	dBuV	dB	dBuV/m	dBuV/m	dBuV/m	dBuV/m	dB	dB	cm	deg	Hor/Ver
1767.50	45.3	32.3	-12.15	33.16	20.16	76.0	56.0	42.84	35.84	100	234	H
2875.00	40.9	27.9	-7.96	32.93	19.93	76.0	56.0	43.07	36.07	100	174	H
2942.50	40.3	28.3	-7.82	32.43	20.43	76.0	56.0	43.57	35.57	100	210	H
1798.13	47.3	34.3	-10.76	36.50	23.50	76.0	56.0	39.50	32.50	100	180	V
2169.38	43.8	30.8	-9.35	34.44	21.44	76.0	56.0	41.56	34.56	100	241	V
2192.50	43.6	30.6	-9.32	34.29	21.29	76.0	56.0	41.71	34.71	100	348	V

3.2.3 Harmonic Current (AC power input port)

Definition:

This part deals with the Limitation of harmonic currents injected into the public supply system.



We were performed the test according to LTA procedure LTA-QI-04.

Test method	: EN 61000-3-2:2014
Test mode	: Rec mode (Adapter)
Rated power	: 3.342 W
Result	: Not Applicable

Measurement Data:

- We did not test EN61000-3-2 (Harmonic current emissions) for the QNO-6032R because equipment whose rated power is less or equal 75W don't need to be tested.

Harmonic Current (AC power input port) / Rec mode (Adapter)

26th April 2019 - 19:13:20		Page 1/1		IECSoft v2_5a	
		IEC61000-3-2:2014			
		Fluctuating Harmonics			
Instrument Details					
Instrument Model	PPA5511				
Serial Number	162-04957				
Firmware Version	2.168				
N4L Calibration Date	18th September 2017				
Instrument Version	Standard				
Test Settings					
Class	Class A				
Mode	Measured				
Equipment Under Test					
Brand	Hanwha Techwin (Tianjin) Co., Ltd.				
Model	QNO-6032R				
Serial	N/A				
Impedance Network ID	N/A				
Test Conditions					
	User Entered		Measured		
Rated Voltage	N/A		230.044V		
Rated Current	N/A		41.880mA		
Rated Frequency	N/A		50.000Hz		
Rated Power	N/A		3.342W		
Additional Test Information					
Measured Power Factor	0.347				
Max Current THD	362.96%				
Max THC	49.865mA				
Max Power	3.392W				
Max F.Current	15.391mA				
Average F.Current	14.557mA				
Minimum Current	100A				
Test Duration	2.5 minutes				
Additional Test Details					
Operator	N/A				
Lab Name	N/A				
Location	N/A				
Notes					
Signature					
Results		Test - N/A. Rated Power < 75W			

Test not applicable

With the exception of lighting equipment section 7 of the IEC61000-3-2:2014 standard declares that no Harmonic current limits are specified for equipment with a rated power of

3.2.4 Voltage Variation and Flicking (AC power input port)

Definition:

This section is concerned with the limitation of voltage fluctuations and flicker impressed on the public low-voltage system.


We were performed the test according to LTA procedure LTA-QI-04.

Test method	:	EN 61000-3-3:2013
Test mode	:	Rec mode (Adapter)
Result	:	Complies

Measurement Data:

- Refer to the Next page

Voltage Variation and Flicking (AC power input port) / Rec mode (Adapter)

26th April 2019 - 00:59:35		Page 1/2	IECSoft v2_5a
		IEC61000-3-3:2013 Ed.3.0 Flickermeter	
Instrument Details			
Instrument Model	PPA5511		
Serial Number	162-04957		
Firmware Version	2.168		
N4L Calibration Date	18th September 2017		
Instrument Version	Standard		
Test Settings			
Class	Voltage		
Mode	Normal (4%)		
Minimum Current	10A		
PST	10.00 minutes		
PLT	12 PSTs		
Equipment Under Test			
Brand	Hanwha Techwin (Tianjin) Co., Ltd.		
Model	QNO-6032R		
Serial	N/A		
Impedance Network ID	N/A		
Test Conditions			
	User Entered	Measured	
Rated Voltage	N/A	230.698V	
Rated Current	N/A	N/A	
Rated Frequency	N/A	50.000Hz	
Rated Power	N/A	N/A	
D max	0.0685% (Limit: 4.0%)		
T max	0.0000 s (Limit: 0.5 s)		
DC max	0.0040% (Limit: 3.3%)		
Additional Test Details			
Operator	N/A		
Lab Name	N/A		
Location	N/A		
Notes			
Signature			
Results	Phase1: PASS		

26th April 2019 - 00:59:35				Ph:1 Page 2/2		IECSoft v2_5a		
IEC61000-3-3:2013 Ed.3.0 Flickermeter								
Instrument Details								
Instrument Model		PPA5511						
Instrument Serial		162-04957						
Instrument Firmware		2.168						
Equipment Under Test								
Brand		Hanwha Techwin (Tianjin) Co., Ltd.						
Model		QNO-6032R						
Serial		N/A						
Flicker Test Results								
PST no.	Status	DC (%)	Dmax (%)	Tmax (s)	PST	PST Lim	PLT	PLT Lim
1	Phase1: PASS	0.004	0.0669	0	0.082	1.00	0.082	N/A
2	Phase1: PASS	0.004	0.0669	0	0.082	1.00	0.082	N/A
3	Phase1: PASS	0.004	0.0669	0	0.082	1.00	0.082	N/A
4	Phase1: PASS	0.004	0.0669	0	0.082	1.00	0.082	N/A
5	Phase1: PASS	0.004	0.06849	0	0.082	1.00	0.082	N/A
6	Phase1: PASS	0.004	0.06849	0	0.082	1.00	0.082	N/A
7	Phase1: PASS	0.004	0.06849	0	0.082	1.00	0.082	N/A
8	Phase1: PASS	0.004	0.06849	0	0.082	1.00	0.082	N/A
9	Phase1: PASS	0.004	0.06849	0	0.082	1.00	0.082	N/A
10	Phase1: PASS	0.004	0.06849	0	0.082	1.00	0.082	N/A
11	Phase1: PASS	0.004	0.06849	0	0.082	1.00	0.082	N/A
12	Phase1: PASS	0.004	0.06849	0	0.082	1.00	0.082	0.65

3.3 IMMUNITY

3.3.1 Electrostatic Discharge

Definition:

The test assesses the ability of the EUT to operate as intended in the event of an electrostatic discharge.

We were performed the test according to LTA procedure LTA-QI-04.

Test date	: 2019.04.25.
Test method	: EN 61000-4-2 :2009
Temperature / Humidity / Pressure	: 23 °C / 38 % R.H. / 100 kPa
Discharge Impedance	: $(330 \pm 10\%) \Omega$ / $(150 \pm 10\%) \text{ pF}$
Type of Discharge (air discharge)	: $\pm 2 \text{ kV}$, $\pm 4 \text{ kV}$, $\pm 8 \text{ kV}$
Type of Discharge (contact discharge)	: $\pm 6 \text{ kV}$
Number of discharges at each point	: 10 of each polarity
Discharge Repetition on Rate	: 1 / sec
Test mode	: Rec mode (Adapter), Rec mode (PoE)
Result	: Complies

Measurement Data:

MODE : Rec mode (Adapter)

1-1. Indirect Discharge

No.	Position	Kind of Discharge	Results	Remarks
1	HCP	Contact	Complies	No reaction recognized
2	VCP	Contact	Complies	No reaction recognized

1-2. Direct Discharge

No.	Position	Kind of Discharge	Result	Remarks
1	Enclosure #1	Contact	Complies	No reaction recognized
2	Enclosure #2	Air	Complies	No reaction recognized
3	Screw	Contact	Complies	No reaction recognized
4	DC IN	Air	Complies	No reaction recognized
5	MIC	Air	Complies	No reaction recognized
6	LAN	Air	Complies	No reaction recognized
7	Alarm OUT	Air	Complies	No reaction recognized
8	Alarm Ground	Air	Complies	No reaction recognized
9	Alarm IN	Air	Complies	No reaction recognized
10	Lens	Air	Complies	No reaction recognized

MODE : Rec mode (PoE)

2-1. Indirect Discharge

No.	Position	Kind of Discharge	Results	Remarks
1	HCP	Contact	Complies	No reaction recognized
2	VCP	Contact	Complies	No reaction recognized

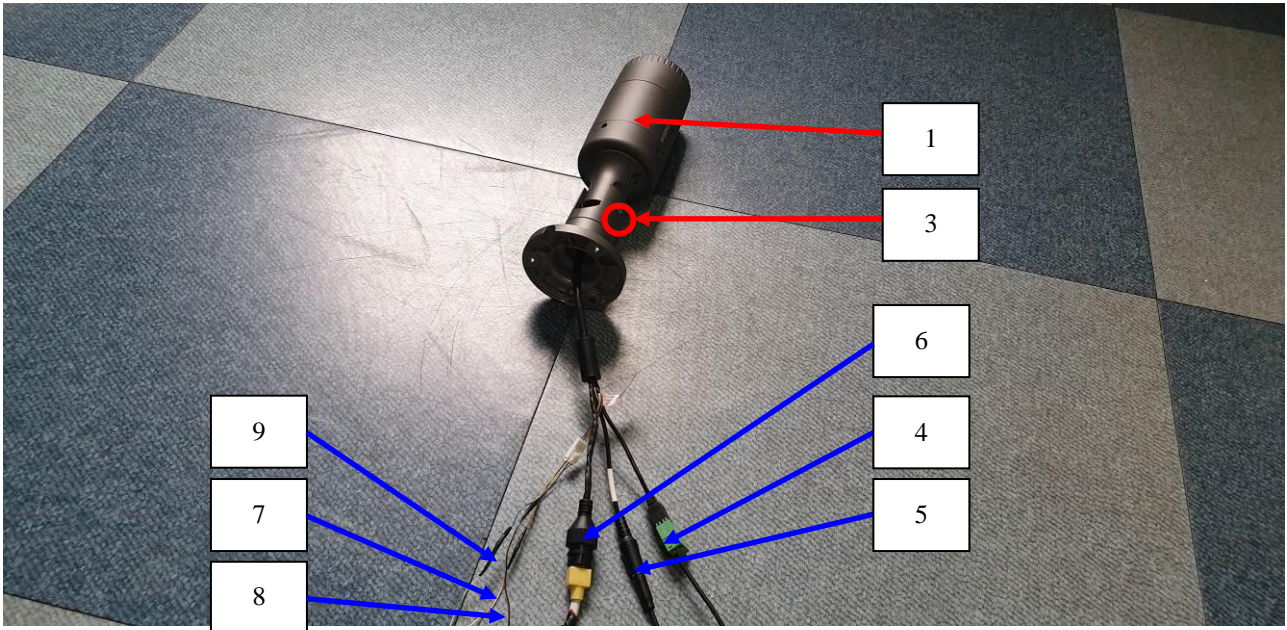
2-2. Direct Discharge

No.	Position	Kind of Discharge	Result	Remarks
1	Enclosure #1	Contact	Complies	No reaction recognized
2	Enclosure #2	Air	Complies	No reaction recognized
3	Screw	Contact	Complies	No reaction recognized
4	MIC	Air	Complies	No reaction recognized
5	LAN	Air	Complies	No reaction recognized
6	Alarm OUT	Air	Complies	No reaction recognized
7	Alarm Ground	Air	Complies	No reaction recognized
8	Alarm IN	Air	Complies	No reaction recognized
9	Lens	Air	Complies	No reaction recognized

※ Results are complies in each test mode.

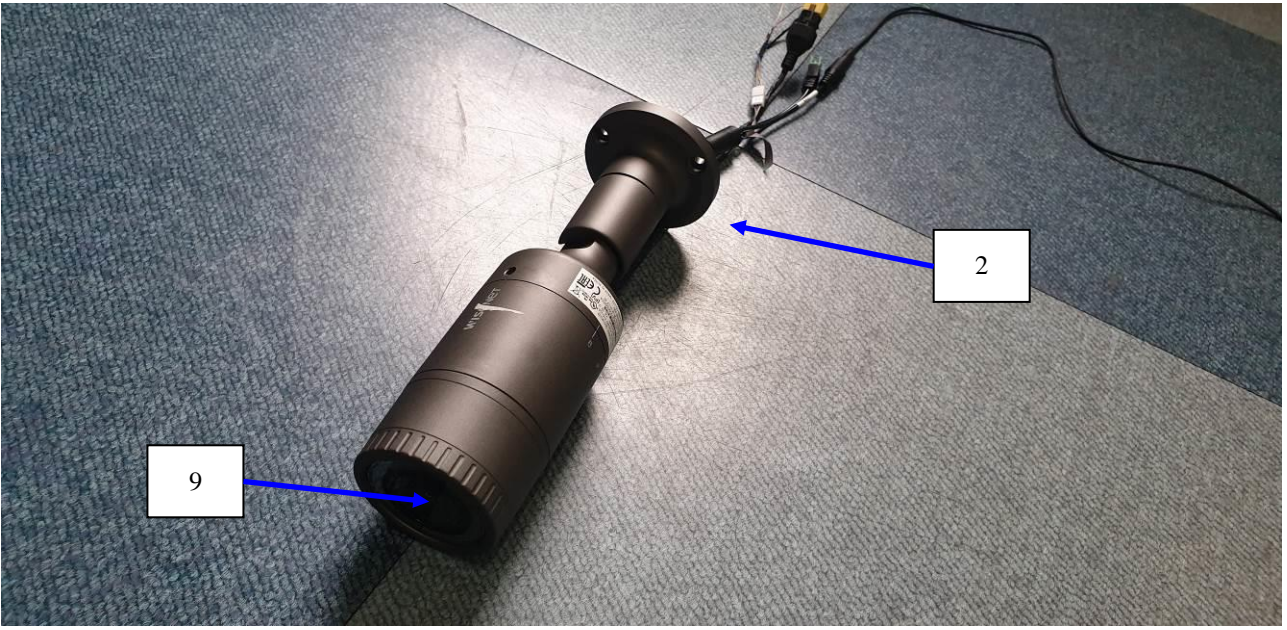
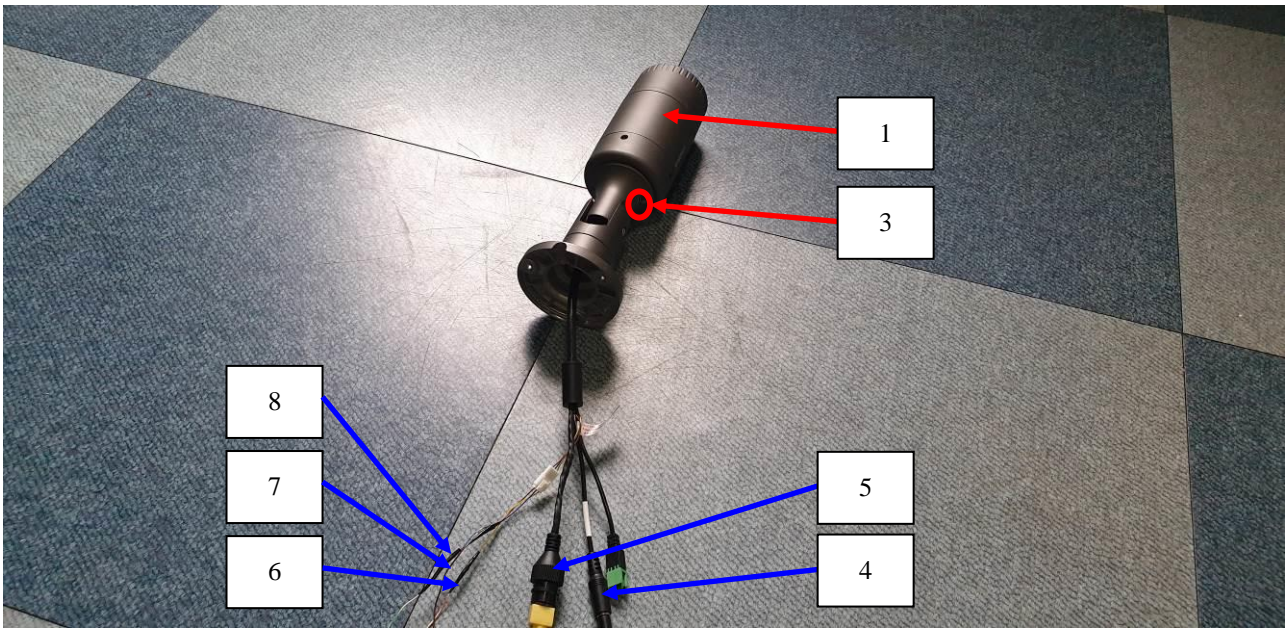
← Air discharge
← Contact discharge

ESD TEST POINT / Rec mode (Adapter)



← Air discharge
← Contact discharge

ESD TEST POINT / Rec mode (PoE)



3.3.2 RF Electromagnetic Field

Definition:

The test assesses the ability of the EUT to operate as intended in the presence of a radio frequency electromagnetic field disturbance.

We were performed the test according to LTA procedure LTA-QI-04.

Test date	:	2019.04.26
Test method	:	EN 61000-4-3:2006/A1:2008/A2:2010
Temperature / Humidity / Pressure	:	23 °C / 39 % R.H. / 100 kPa
Frequency range	:	80 MHz to 2,700 MHz
Test level	:	10 V/m (measured unmodulated)
Amplitude Modulation	:	AM, 80 %, 1 kHz Sinusoidal PM, 1 Hz (0.5s ON : 0.5s OFF)
Step size	:	1 % of fundamental
Dwell Time	:	3 s
Test mode	:	Rec mode (Adapter), Rec mode (PoE)
Result	:	Complies

Measurement Data:

MODE : Rec mode (Adapter)

Port	Side	Result	Remarks
Horizontal	Front	Complies	No reaction recognized
	Left	Complies	No reaction recognized
	Rear	Complies	No reaction recognized
	Right	Complies	No reaction recognized
Vertical	Front	Complies	No reaction recognized
	Left	Complies	No reaction recognized
	Rear	Complies	No reaction recognized
	Right	Complies	No reaction recognized

MODE : Rec mode (PoE)

Port	Side	Result	Remarks
Horizontal	Front	Complies	No reaction recognized
	Left	Complies	No reaction recognized
	Rear	Complies	No reaction recognized
	Right	Complies	No reaction recognized
Vertical	Front	Complies	No reaction recognized
	Left	Complies	No reaction recognized
	Rear	Complies	No reaction recognized
	Right	Complies	No reaction recognized

※ Results are complies in each test mode.

3.3.3 Electrical fast transients

Definition:

The test assesses the ability of the EUT to operate as intended in the event of fast transients presence on one of the input/output ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test date	:	2019.04.25.
Test method	:	EN 61000-4-4:2012
Temperature / Humidity / Pressure	:	23 °C / 38 % R.H. / 100 kPa
Cable length	:	> 3 m
Test level	:	2.0 kV (AC power input port) 1.0 kV (Signal port)
Polarity	:	Negative/ positive
Repetition frequency	:	100 kHz
Test mode	:	Rec mode (Adapter), Rec mode (PoE)
Result	:	Complies

Measurement Data:

MODE : Rec mode (Adapter)

Power Line	Test level	Result	Remarks
L – N	± 2 kV	Complies	No reaction recognized

Signal Line	Test level	Result	Remarks
LAN	± 1 kV	Complies	No reaction recognized

MODE : Rec mode (PoE)

Signal Line	Test level	Result	Remarks
LAN	± 1 kV	Complies	No reaction recognized

※ Results are complies in each test mode.

3.3.4 Surge

Definition:

The test assesses the ability of the EUT to operate as intended in the event of surge presence on the AC main power input ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test date	:	2019.04.25.
Test method	:	EN 61000-4-5:2014/A1:2017
Temperature / Humidity / Pressure	:	23 °C / 38 % R.H. / 100 kPa
Test level	:	± 0.5 kV, ±1 kV (line to line) ± 0.5 kV, ± 1 kV, ± 2 kV (line to ground), ± 0.5 kV, ± 1 kV (signal line)
Polarity	:	Negative/ positive
Wave shape	:	1.2/ 50 µs pulse
Number of surges	:	5 (at each phase)
Test mode	:	Rec mode (Adapter), Rec mode (PoE)
Result	:	Complies

Measurement Data:

MODE : Rec mode (Adapter)

Phase	Line	level	Result	Remark
0°	Line(L) to line(N)	± 0.5, 1.0 kV	Complies	No reaction recognized
90°	Line(L) to line(N)	± 0.5, 1.0 kV	Complies	No reaction recognized
180°	Line(L) to line(N)	± 0.5, 1.0 kV	Complies	No reaction recognized
270°	Line(L) to line(N)	± 0.5, 1.0 kV	Complies	No reaction recognized

Signal Line	Test level	Result	Remarks
LAN	± 0.5, 1.0 kV	Complies	No reaction recognized

MODE : Rec mode (PoE)

Signal Line	Test level	Result	Remarks
LAN	± 0.5, 1.0 kV	Complies	No reaction recognized

※ Results are complies in each test mode.

3.3.5 Conducted disturbances, induced by radio-frequency fields

Definition:

The test assesses the ability of the EUT to operate as intended in the presence of a radio frequency electromagnetic disturbance on the input/output ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test date	:	2019.04.25.
Test method	:	EN 61000-4-6:2014/AC:2015
Temperature / Humidity / Pressure	:	23 °C / 38 % R.H. / 100 kPa
Frequency range	:	0.15MHz – 100 MHz
Test level	:	10 Vrms unmodulated
Amplitude Modulation	:	AM, 80 %, 1 kHz Sinusoidal PM, 1 Hz (0.5s ON : 0.5s OFF)
Step size	:	1 % of fundamental.
Test mode	:	Rec mode (Adapter), Rec mode (PoE)
Result	:	Complies

Measurement Data:

MODE : Rec mode (Adapter)

Power Port	Result	Remarks
Power	Complies	No reaction recognized

Signal Port	Result	Remarks
LAN	Complies	No reaction recognized

MODE : Rec mode (PoE)

Signal Port	Result	Remarks
LAN	Complies	No reaction recognized

※ Results are complies in each test mode.

3.3.6 Mains supply voltage dips, short interruptions

Definition:

The test assesses the ability of the EUT to operate as intended in the event of voltage dips and interruptions present on the AC mains power input ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test date : 2019.04.25.
 Test method : EN 61000-4-11:2004/A1:2017
 Temperature / Humidity / Pressure : 23 °C / 38 % R.H. / 100 kPa
 Ut : 230 Vac
 Test mode : Rec mode (Adapter)
 Result : **Complies**

Measurement Data:

MODE : Rec mode (Adapter)

Test Level % Ut	Voltage droop and interruptions % Ut	Duration of Reduction (period)	Result	Remarks
80	20	250	Complies	No reaction recognized
70	30	25	Complies	No reaction recognized
40	60	10	Complies	No reaction recognized
0	100	250	Complies	EUT Power OFF during the test. Automatic replay without user's control. After the test, EUT was operated normally.

3.3.7 Mains supply voltage variations

Definition:

The test assesses the ability of the EUT to operate as intended in the event of voltage variations present on the AC mains power input ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test date	:	2019.04.25.
Test method	:	EN 50130-4:2011/A1:2014
Temperature / Humidity / Pressure	:	24 °C / 39 % R.H. / 100.7 kPa
Supply Voltage maximum	:	$U_{nom} + 10 \%$
Supply Voltage minimum	:	$U_{nom} - 15 \%$
U_t	:	230 Vac
Test mode	:	Rec mode (Adapter)
Result	:	Complies

Measurement Data:

U_{nom} = Nominal mains voltage. Where provision is made to adapt the equipment to suit a number of nominal supply voltages (e.g. by transformer tap changing), the above conditioning severity shall be applied for each nominal voltage, with the equipment suitably adapted. For equipment which is claimed to be suitable for a range of nominal mains voltages (e.g. 220/240 V) without adaptation, $U_{max} = (\text{Maximum } U_{nom}) + 10 \%$, and $U_{min} = (\text{Minimum } U_{nom}) - 15 \%$. In any case the range of U_{nom} must include the European nominal mains voltage of 230 V.

2 Mains supply voltage variations

MODE : Rec mode (Adapter) / 230 V, 50 Hz

Test LevelCondition		Test Level (V)	Result	Remarks
U_{nom}	+10%	253	Complies	No reaction recognized
U_{nom}	-15%	195.5	Complies	No reaction recognized

APPENDIX A

TEST EQUIPMENT AND ANCILLARIES USED FOR TESTS

To facilitate inclusion on each page of the test equipment used for related tests, each item of test equipment are identified by the Test Laboratory.

Conducted emissions

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	EMI TEST Receiver	ESR	Rohde & Schwarz	101499	2019.07.11	1 year
<input checked="" type="checkbox"/>	Pulse Limiter	ESH3-Z2	Rohde & Schwarz	100710	2020.03.16	1 year
<input type="checkbox"/>	LISN	ESH3-Z6	Rohde & Schwarz	100378	2019.09.07	1 year
<input type="checkbox"/>	LISN	ESH3-Z6	Rohde & Schwarz	101468	2019.09.07	1 year
<input checked="" type="checkbox"/>	LISN(main)	ENV216	Rohde & Schwarz	100408	2019.10.10	1 year
<input checked="" type="checkbox"/>	LISN(sub)	LT32C/10	AFJ	32031518210	2019.09.06	1 year
<input checked="" type="checkbox"/>	TEST PROGRAM	e3_ce 20181212a (V9)	AUDIX	-	-	-
<input checked="" type="checkbox"/>	ISN	ISN T800	TESEQ	27109	2019.09.12	1 year
<input type="checkbox"/>	ISN	ENY81-CA6	Rohde & Schwarz	101565	2019.09.12	1 year
<input type="checkbox"/>	CURRENT PROBE	EZ-17	Rohde & Schwarz	100508	2019.09.06	1 year

Radiated Emission – Below 1 GHz

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	EMI TEST Receiver	ESU	Rohde & Schwarz	100092	2019.09.06	1 year
<input checked="" type="checkbox"/>	Amplifier (25 dB)	8447D	HP	2944A07684	2019.09.06	1 year
<input checked="" type="checkbox"/>	BILOG Antenna	VULB9168	SCHWARZBECK	775	2020.03.16 (KOLAS)	2 year
<input checked="" type="checkbox"/>	TEST PROGRAM	e3 20181212a (V9)	AUDIX	-	-	-

Radiated Emission – Above 1 GHz

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	EMI TEST Receiver	ESU	Rohde & Schwarz	100092	2019.09.06	1 year
<input checked="" type="checkbox"/>	Amplifier	8449B	HP	3008A00671	2019.09.06	1 year
<input checked="" type="checkbox"/>	HORN ANTENNA	3115	ETS	114105	2019.11.03 (KOLAS)	2 year
<input checked="" type="checkbox"/>	TEST PROGRAM	e3 20181212a (V9)	AUDIX	-	-	-

Harmonic Current / Voltage Variation and Flicking

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	Precision Power Analyzer	PPA5511	Newtons4th Ltd	162-04957	2019.09.10	1 year
<input checked="" type="checkbox"/>	Reference Impedance Network	ES4152	NF Corp.	9074424	2019.09.07	1 year

Electrostatic Discharge

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	ESD Simulator	ESS-2000	NOISEKEN	8000C03241	2019.09.11	1 year
<input checked="" type="checkbox"/>	ESD GUN	TC-815R	NOISEKEN	ESS0564361	2019.09.11	1 year

RF Electromagnetic Field

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	Signal Generator	E4432B	Agilent	MY41310632	2020.03.16	1 year
<input checked="" type="checkbox"/>	Power Meter	E4419B	Agilent	GB38410133	2020.03.16	1 year
<input checked="" type="checkbox"/>	Power Sensor	E9300A	Agilent	MY41497992	2020.03.16	1 year
<input checked="" type="checkbox"/>	Power Sensor	E9300A	Agilent	MY41497618	2020.03.16	1 year
<input checked="" type="checkbox"/>	RF POWER AMPLIFIER	ITA0300KL-300	INFINITECH	0300KL 1507 001	-	-
<input checked="" type="checkbox"/>	RF POWER AMPLIFIER	ITA2000KL-120	INFINITECH	200KL 1507 001	-	-
<input checked="" type="checkbox"/>	RF POWER AMPLIFIER	ITA4500KL-70	INFINITECH	4500KL 1507 001	-	-
<input checked="" type="checkbox"/>	RF POWER AMPLIFIER	ITA0750KL-300	INFINITECH	0750KL 1507 001	-	-
<input checked="" type="checkbox"/>	Log.-Per.Antenna (80 MHz ~ 3 GHz)	K9128	RAPA	NONE	-	-

Electrical fast transients

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	Compact Generator	Compact NX	EMTEST	P1725200196	2019.09.06	1 year
<input checked="" type="checkbox"/>	AC Power Source	Variac NX	EMTEST	P1745207276	2019.09.06	1 year
<input checked="" type="checkbox"/>	Capacitive Coupling Clamp	CCI	EMTEST	P1744207071	2019.09.06	1 year

Surge

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	Compact Generator	Compact NX	EMTEST	P1725200196	2019.09.06	1 year
<input checked="" type="checkbox"/>	AC Power Source	Variac NX	EMTEST	P1745207276	2019.09.06	1 year
<input checked="" type="checkbox"/>	CDN	CNV 508T5	EMTEST	P1742204978	2019.09.07	1 year
<input type="checkbox"/>	CDN	CNV 508N1	EMTEST	P1742204940	2019.09.07	1 year

Conducted disturbances, induced by radio-frequency fields

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	Signal generator	SML03	R&S	103026/0013	2020.03.16	1 year
<input checked="" type="checkbox"/>	POWER METER	NRVD	R&S	101689	2020.03.16	1 year
<input checked="" type="checkbox"/>	POWER Sensor	URV5-Z2	R&S	100755	2020.03.16	1 year
<input checked="" type="checkbox"/>	POWER Sensor	URV5-Z2	R&S	100756	2020.03.16	1 year
<input checked="" type="checkbox"/>	RF Power Amplifier	FLL75A	FRANKONIA	1033	-	-
<input checked="" type="checkbox"/>	EM INJECTION CLAMP	TSIC-23	F.C.C	529	2020.03.25	1 year
<input type="checkbox"/>	CDN (M1)	TSCDN-M1-16A	F.C.C	07004	2020.03.16	1 year
<input checked="" type="checkbox"/>	CDN (M2) (main)	TSCDN-M2-16A	F.C.C	07008	2019.09.06	1 year
<input type="checkbox"/>	CDN (M2)	TSCDN-M2-16A	F.C.C	07009	2020.03.16	1 year
<input type="checkbox"/>	CDN (M3)	TSCDN-M3-16A	F.C.C	07016	2020.03.16	1 year
<input checked="" type="checkbox"/>	CDN (M3) (sub)	TSCDN-M3-16A	F.C.C	07017	2019.09.06	1 year

Mains supply voltage dips, short interruptions

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	Compact Generator	Compact NX	EMTEST	P1725200196	2019.09.06	1 year
<input checked="" type="checkbox"/>	AC Power Source	Variac NX	EMTEST	P1745207276	2019.09.06	1 year

Mains supply voltage variations

	Item	Model Name	Manufacturer	Serial No.	Next Cal.	Interval
<input checked="" type="checkbox"/>	Compact Generator	Compact NX	EMTEST	P1725200196	2019.09.06	1 year
<input checked="" type="checkbox"/>	AC Power Source	Variac NX	EMTEST	P1745207276	2019.09.06	1 year

APPENDIX B

PERFORMANCE CRITERIA

Performance criteria

The variety and the diversity of the apparatus within the scope of this document makes it difficult to define precise criteria for the evaluation of the immunity test results.

If as a result of the application of the tests defined in this standard, the apparatus becomes dangerous or unsafe then the apparatus shall be deemed to have failed the test.

A functional description and a definition of performance by the manufacture and noted in the test report, based on the following criteria:

Electrostatic discharge

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of discharge is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test (see Clause 6), after the conditioning.

Radiated electromagnetic fields

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change, and no such flickering of indicators occurs at a field strength of 3 V/m.

For components of CCTV systems, where the status is monitored by observing the TV picture, then deterioration of the picture is allowed at 10 V/m, providing.

(a) there is no permanent damage or change to the EUT

(e.g. no corruption of memory or changes to programmable setting etc.)

(b) at 3 V/m, any deterioration of the picture is so minor that the system could still be used; and

(c) there is no observable deterioration of the picture at 1 V/m.

The EUT shall meet the acceptance criteria for the functional test(see Clause 6), after the conditioning.

Fast transient burst / slow high energy voltage surge

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of the bursts is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test (see Clause 6), after the conditioning.

Slow high energy voltage surge

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of the surges is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test (see Clause 6), after the conditioning.

Conducted RF immunity

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change, and no such flickering of indicators occurs at $U_0 = 130 \text{ dB}\mu\text{V}$.

For components of CCTV systems, where the status is monitored by observing the TV picture, then deterioration of the picture is allowed at $U_0 = 140 \text{ dB}\mu\text{V}$, providing

(a) there is no permanent damage or change to the EUT

(e.g. no corruption of memory or changes to programmable settings, etc.)

(b) at $U_0 = 130 \text{ dB}\mu\text{V}$, any deterioration of the picture is so minor that the system could still be used, and

(c) there is no observable deterioration of the picture at $U_0 = 120 \text{ dB}\mu\text{V}$.

The EUT shall meet the acceptance criteria for the functional test(see Clause 6), after the conditioning.

Voltage dip/interruption

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. The EUT shall meet the acceptance criteria for the functional test(see Clause 6), after the conditioning.

It is permitted to use ancillary equipment (e.g. A UPS) to meet the requirements of this clause. This shall be detailed in the test report and the manufacturer's installation manual.

Signaling a mains fault during the 100 % voltage reduction test is permitted.

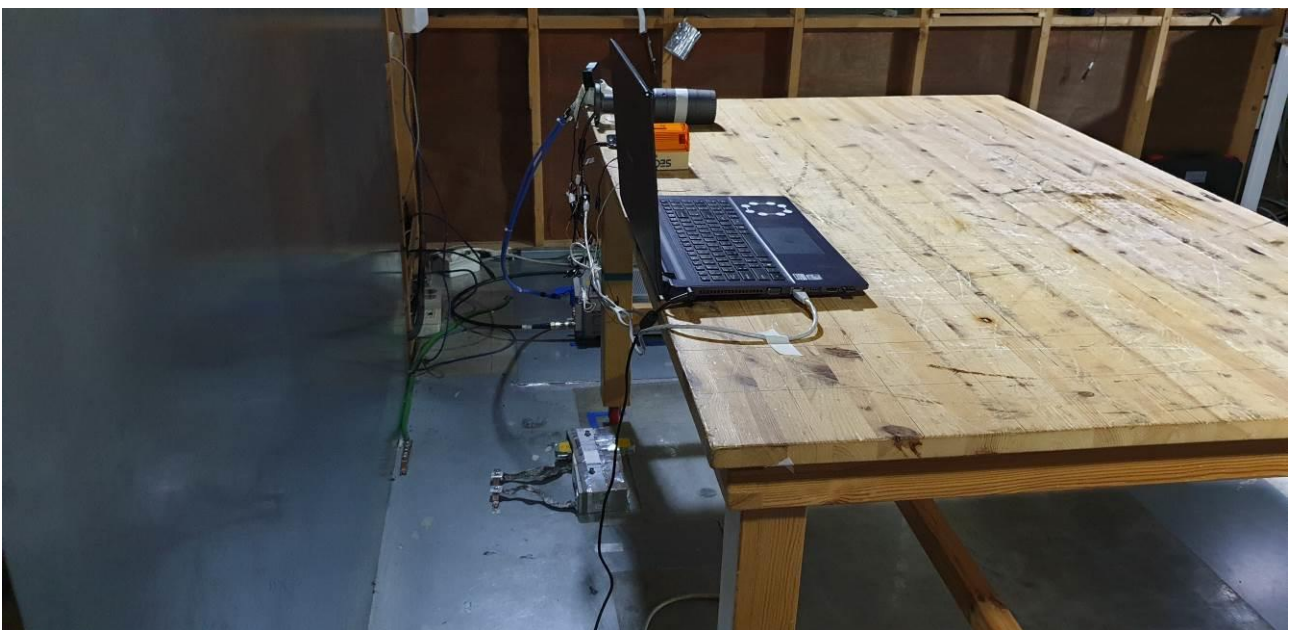
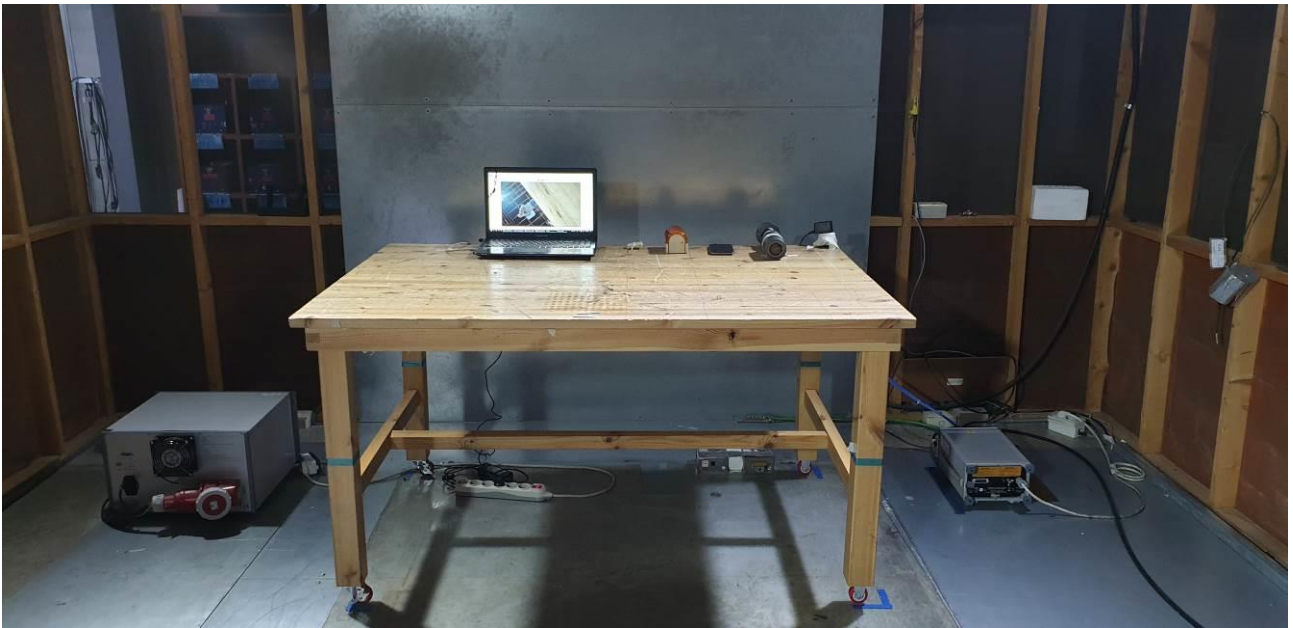
Mains supply voltage variations

There shall be no damage, malfunction or change of status due to the different supply voltage conditions. The EUT shall meet the acceptance criteria for the functional test(see Clause 6), during the conditioning.

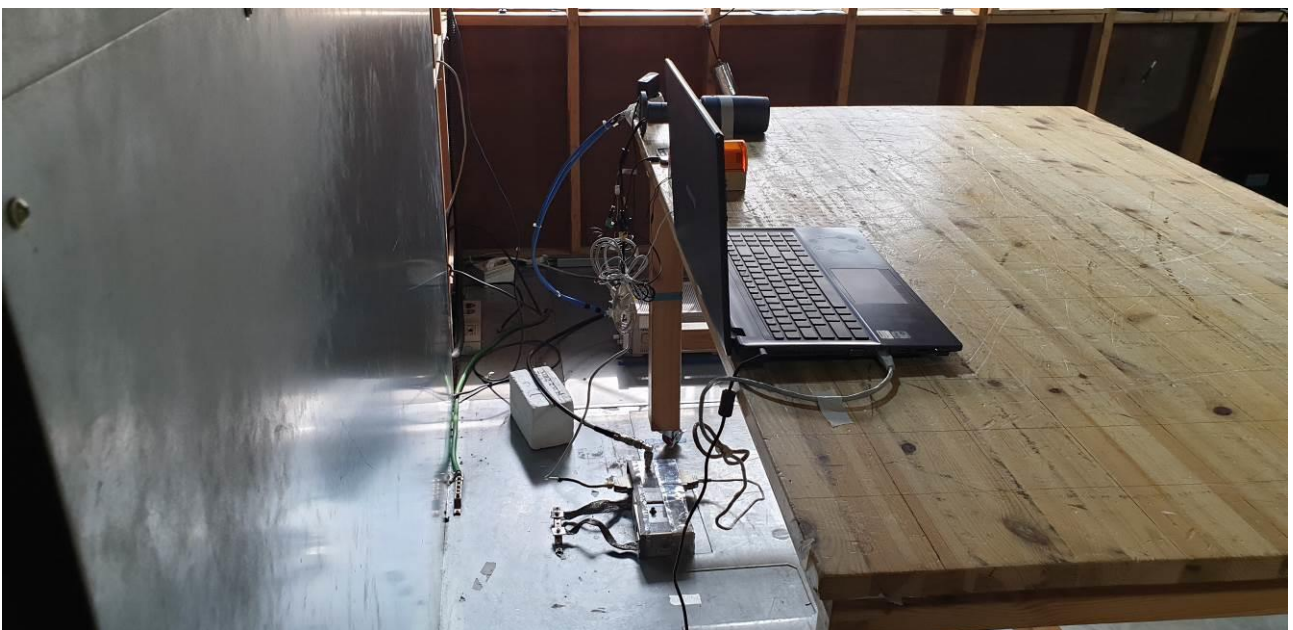
APPENDIX C

PHOTOGRAPHS

Conducted emission (Maximum emission configuration) / Rec mode (Adapter)



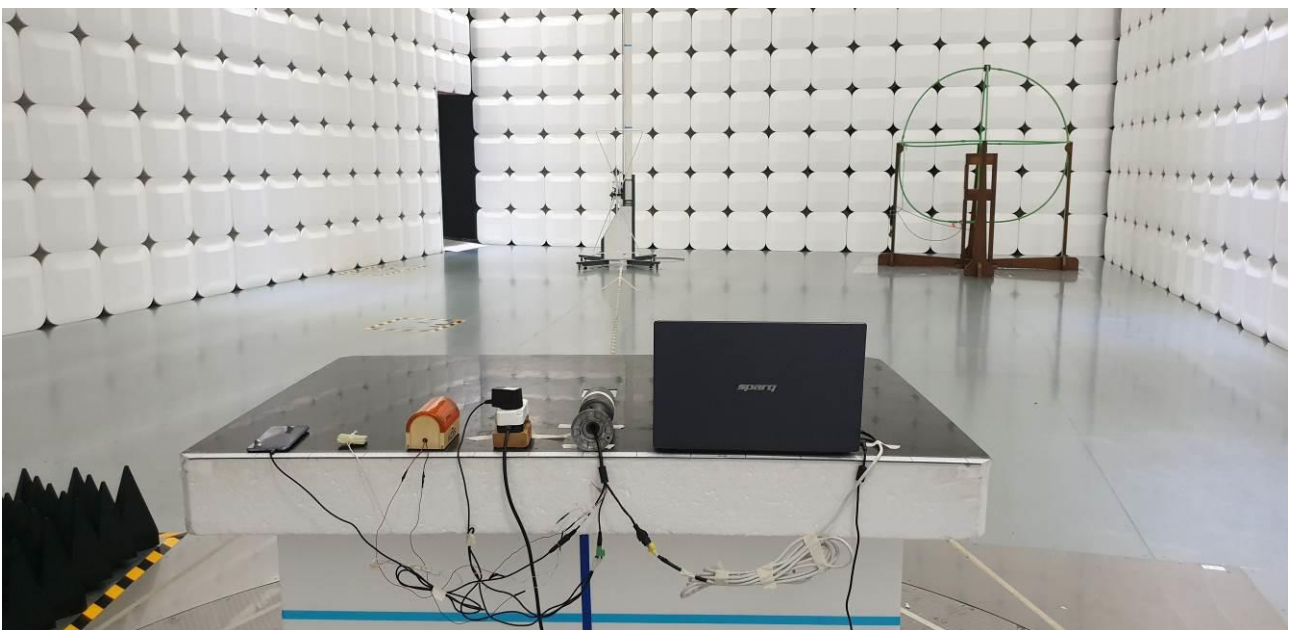
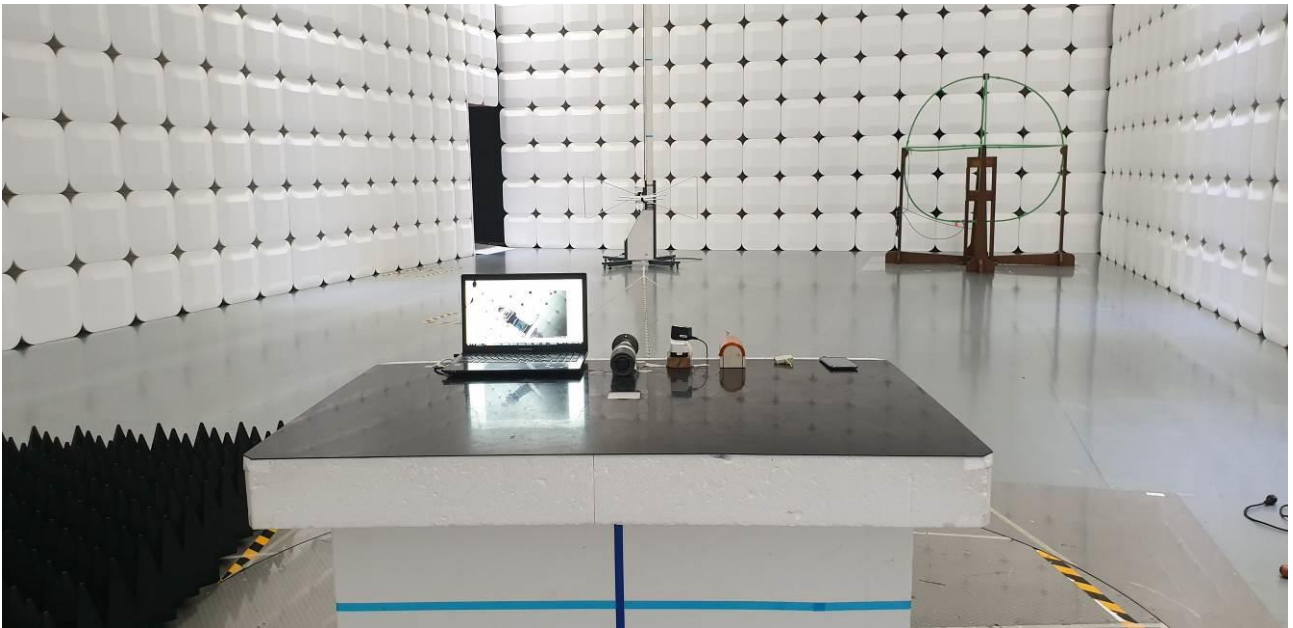
Conducted emission (Maximum emission configuration) / TEL _ Rec mode (Adapter)



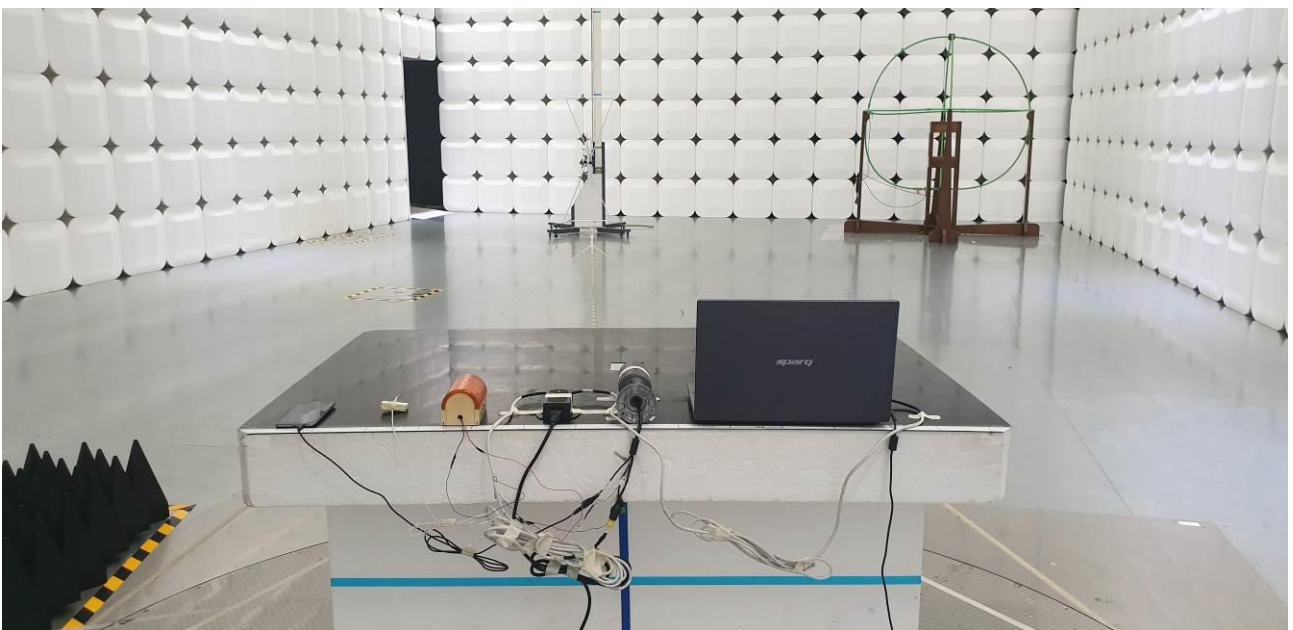
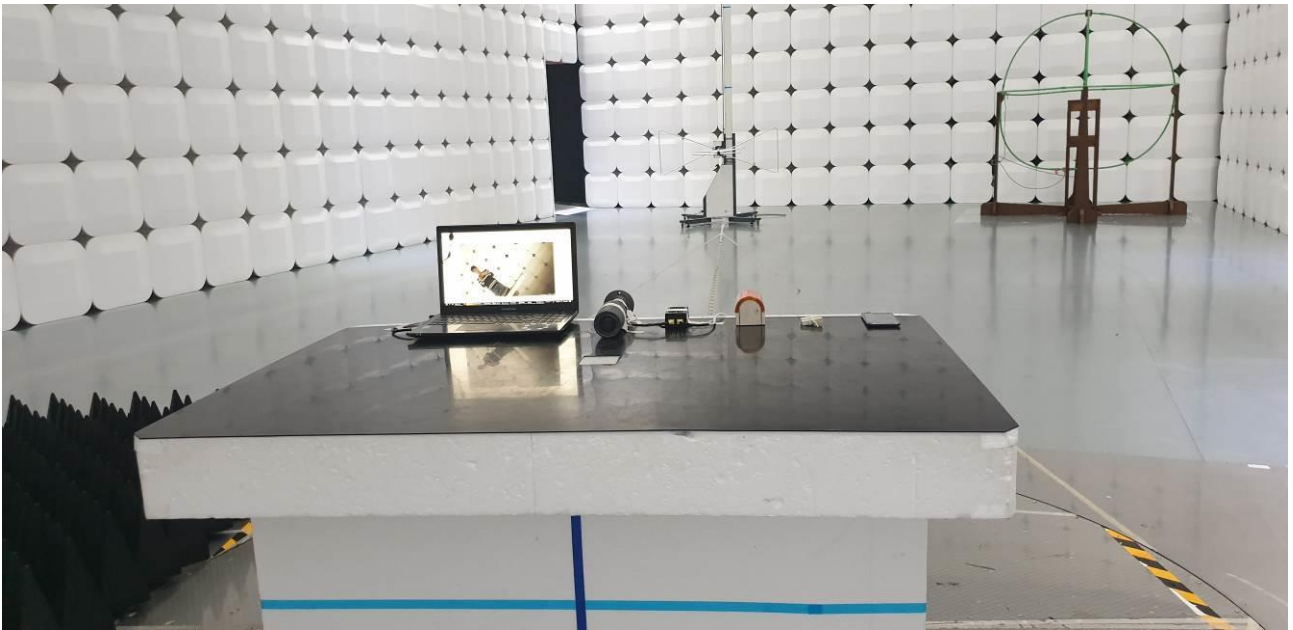
Conducted emission (Maximum emission configuration) / TEL _ Rec mode (PoE)



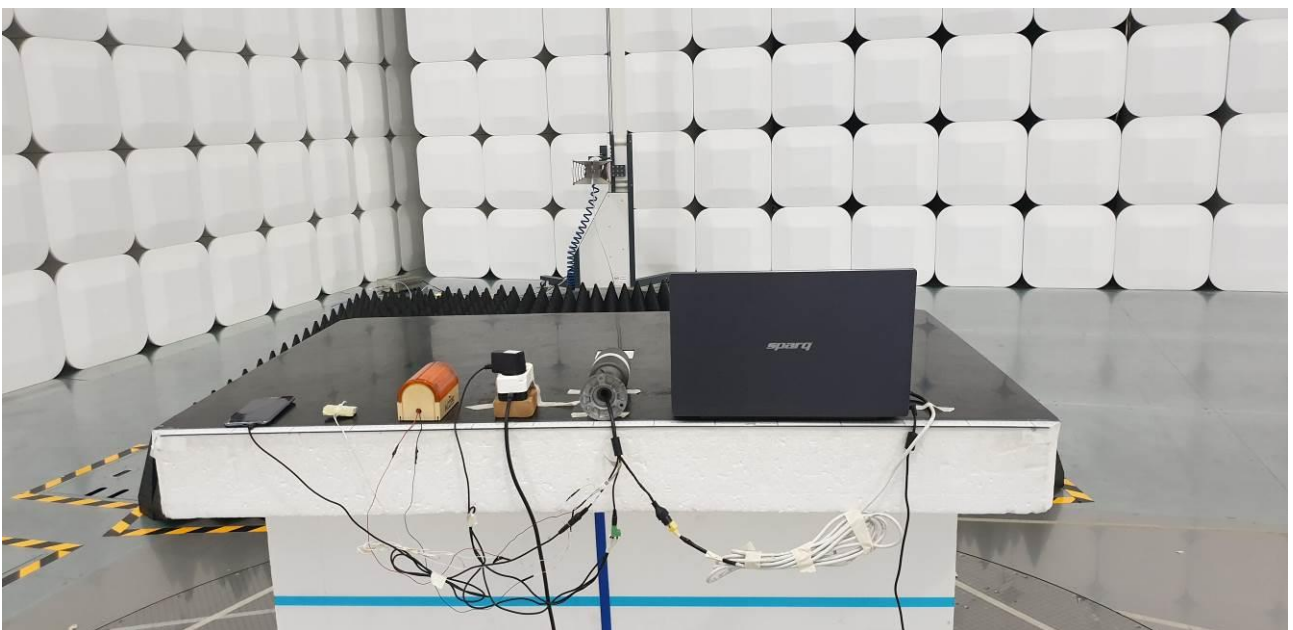
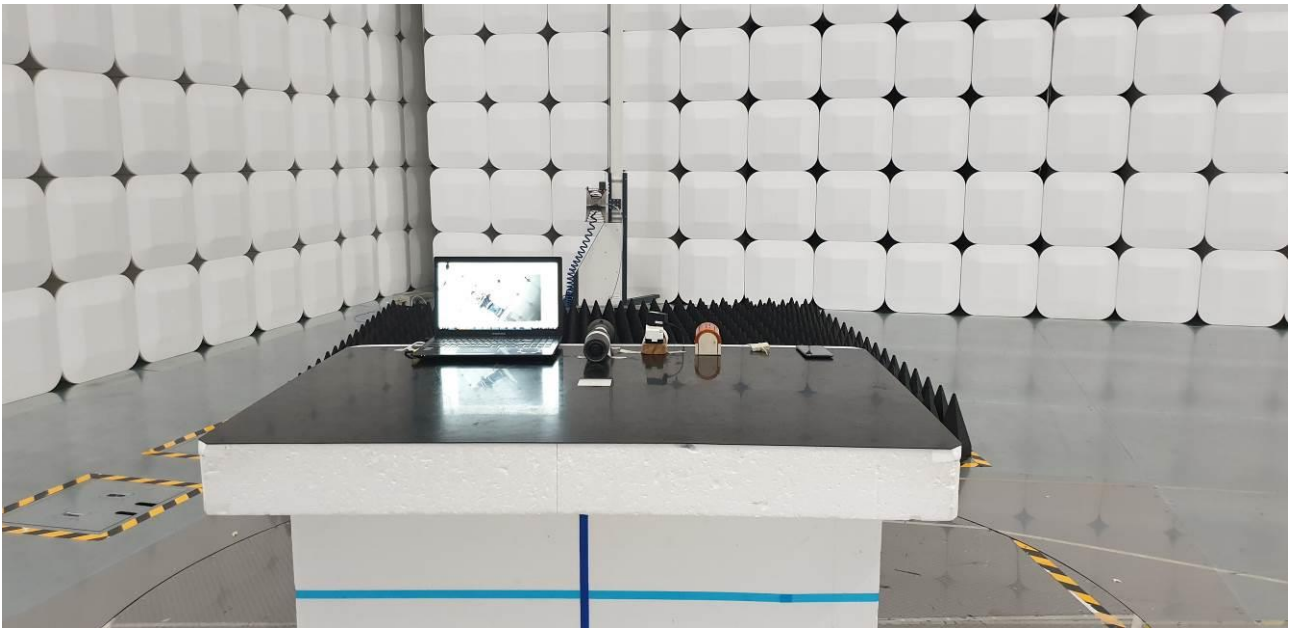
Radiated emission (Maximum emission configuration)-Below 1 GHz / Rec mode (Adapter)



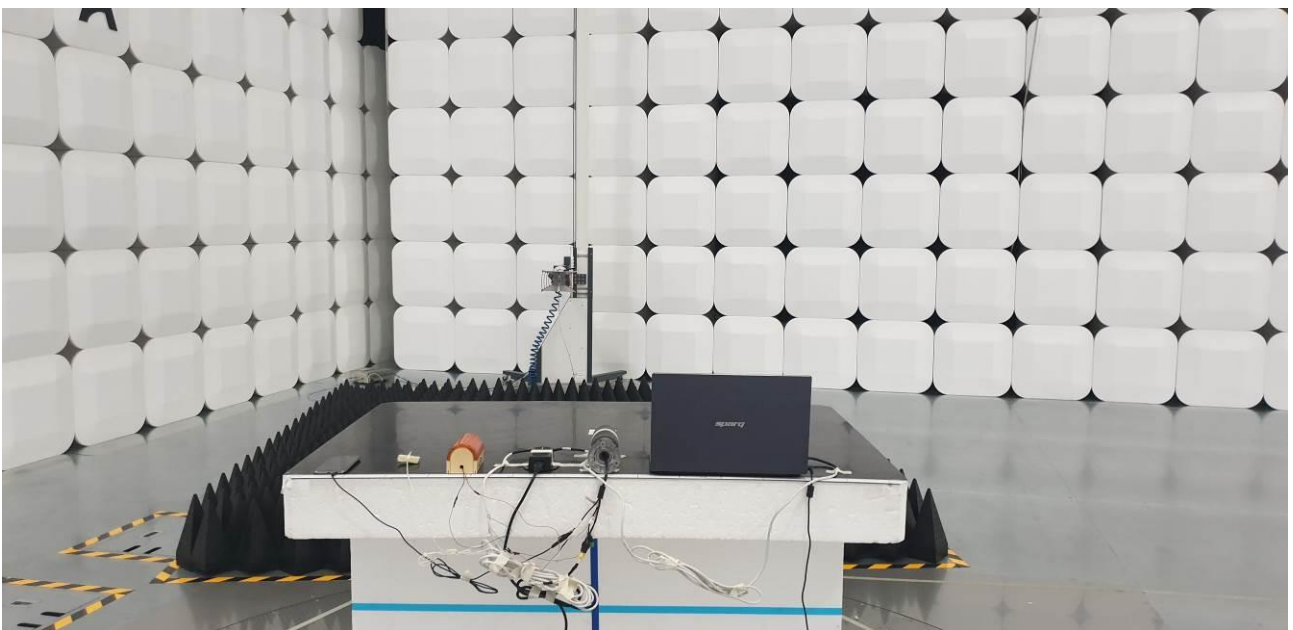
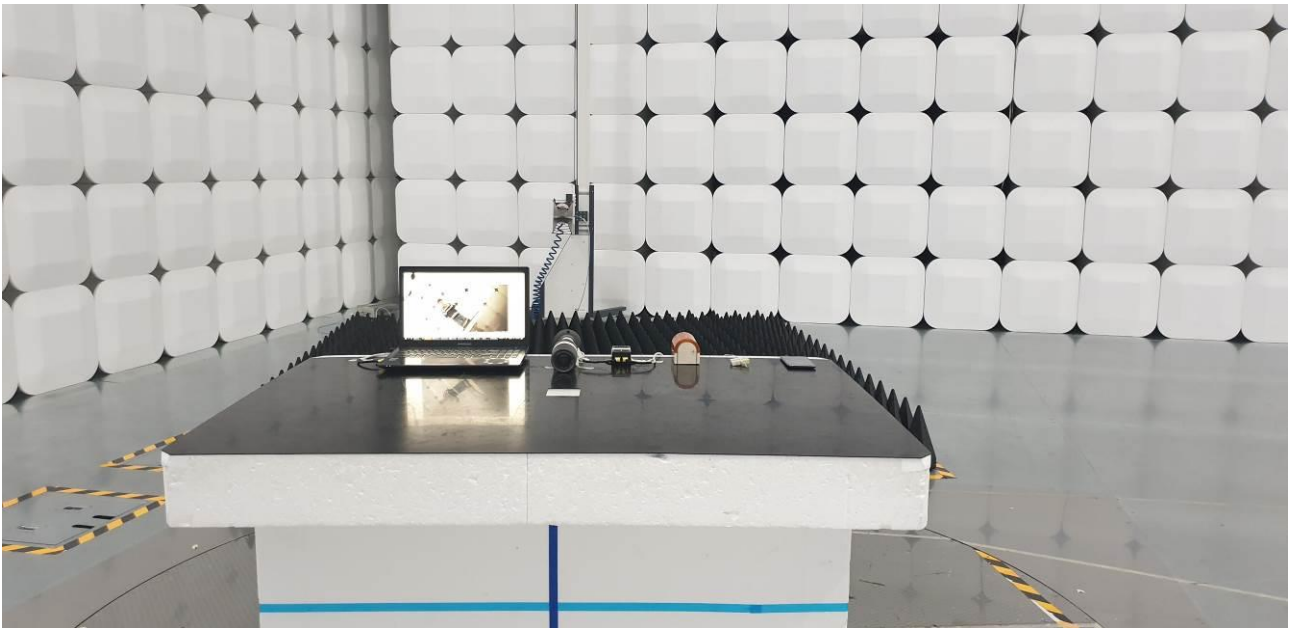
Radiated emission (Maximum emission configuration)-Below 1 GHz / Rec mode (PoE)



Radiated emission (Maximum emission configuration) – Above 1GHz / Rec mode (Adapter)



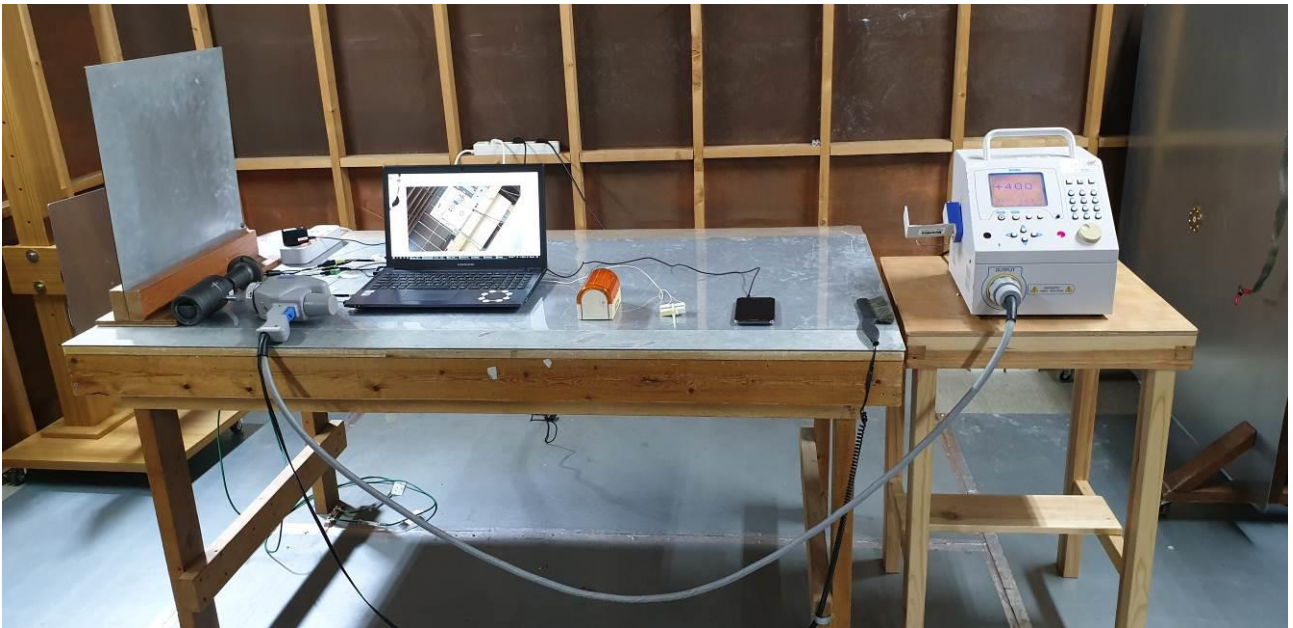
Radiated emission (Maximum emission configuration) – Above 1GHz / Rec mode (PoE)



Harmonic Current / Voltage Variation and Flicking / Rec mode (Adapter)



Electrostatic discharge / Rec mode (Adapter)



Electrostatic discharge / Rec mode (PoE)



RF Electromagnetic Field / Rec mode (Adapter)



RF Electromagnetic Field / Rec mode (PoE)



Electrical fast transients / Rec mode (Adapter)



Electrical fast transients / Rec mode (PoE)



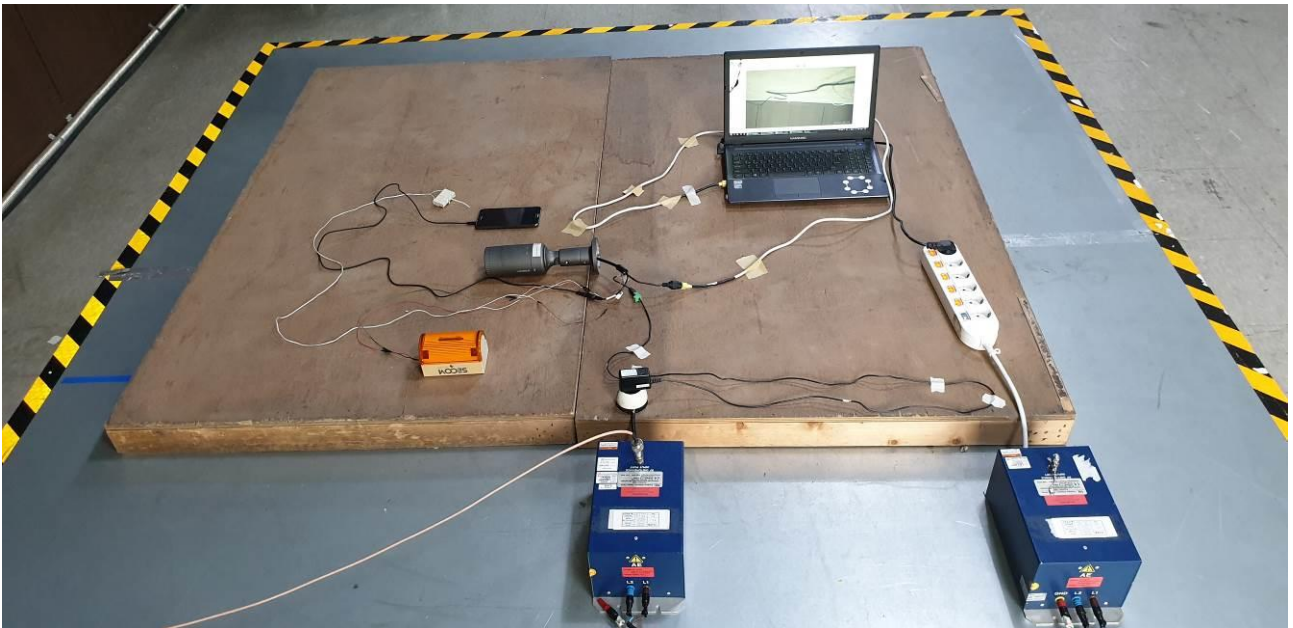
Surge / Rec mode (Adapter)



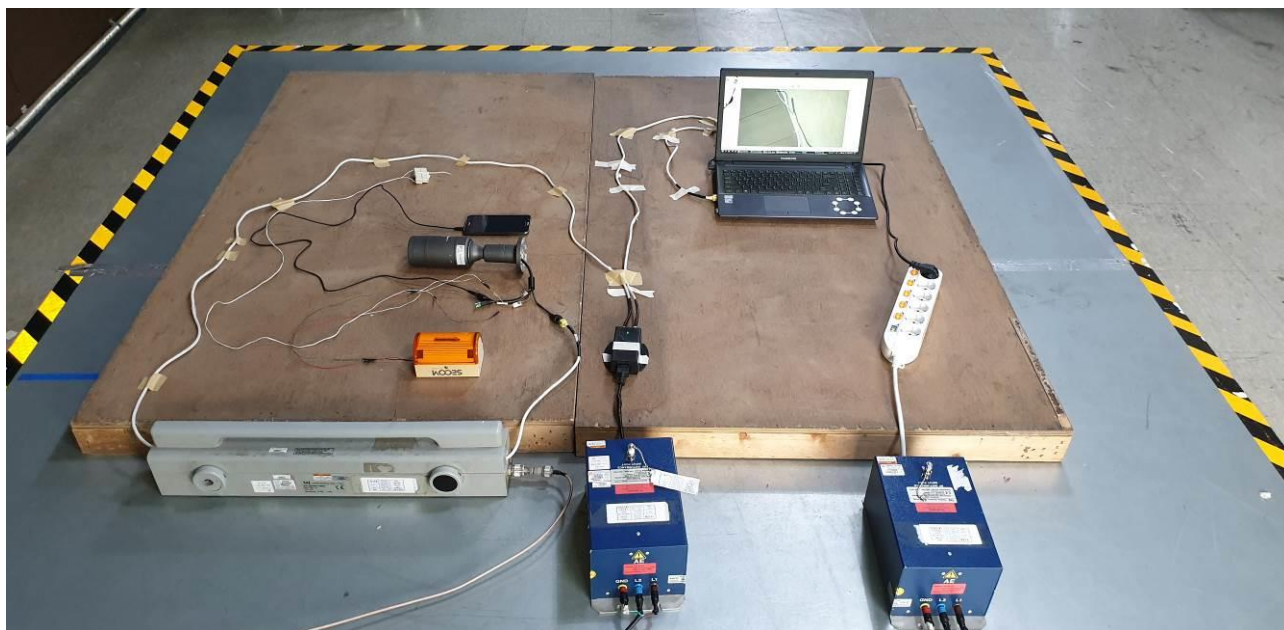
Surge / Rec mode (PoE)



Conducted Disturbances, Induced by Radio-Frequency Fields / Rec mode (Adapter)



Conducted Disturbances, Induced by Radio-Frequency Fields / Rec mode (PoE)



Main supply voltage (dips, variations) short interruptions / Rec mode (Adapter)



EUT



EUT

